國立交通大學環境工程研究所碩士論文

晶體內部與表面摻雜釩離子對二氧化鈦光觸媒 物化特性與光催化活性之影響

Effect of surface and lattice vanadium ions on the physicochemical and photocatalytic properties of TiO₂

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中文摘要

本研究利用溶膠-凝膠法(sol-gel)及表面溶膠-凝膠法(surface sol-gel)製備釩離子摻雜 之二氧化鈦(TiO₂),並探討晶體內部(bulk doping)或表面(surface doping)釩離子對於TiO₂ 材料及物化特性之影響。研究結果顯示單純 TiO₂經 300°C 鍛燒後呈現 69.9 wt%的銳鈦 礦(anatase)與 31.1 wt%的金紅石,同時銳鈦礦的平均晶粒為 6.1 nm,巨體摻雜後並未明 顯改變 TiO₂ 晶粒尺寸,其晶粒大小範圍為 6.0 至 6.5 nm 間,然而在 V/Ti 比例高於 1.27× 10⁻³ 時完全抑制金紅石晶相 (Rutile)的形成,此外,由於鍛燒溫度略高於坦曼溫度,所 以釩會遷移至表面形成 V₂O₅ 晶相。由低濃度摻雜釩的 UV-Vis 圖譜中,發現巨體摻雜 TiO_2 於 250~320 nm 間有 V^{5+} 吸收波峰產生,證實摻雜釩於晶體內部會於 TiO_2 能帶間導 入額外能階,然而當 V/Ti 草爾比高於 1.00%,部分 V^{5+} 會還原成 V^{4+} ,而因為 V^{4+} 會同 時捕捉電子電洞降低表面電荷轉移,所以降解 0.01 mM Rhodamine (RhB)之擬一階反應 速率常數隨著晶格內釩離子濃度的增加,而從 5.20×10⁻² 降至 1.50×10⁻² 1/min,利用 EPR 偵測觸媒表面 OH 自由基,其積分面積從 5.40×10^7 降至 5.50×10^6 ,證實電子轉移的效率 會隨晶格內釩離子濃度增加而變差。相較下,表面摻雜對 TiO2 的微結構及電子結構並 無巨觀的影響,但表面摻雜釩的反應速率常數卻隨著表面 V5+濃度增加而從 5.20×10⁻²提 升至 9.80×10^{-2} $1/\min$, 當 V/Ti 約為 1.00×10^{-2} 時, 表面掺雜 TiO_2 的反應速率數高於內部 摻雜觸媒的六倍,此原因為表面的 V^{5+} 易使電子累積於 TiO_2 表面,增進表面電荷轉移速 率(觸媒表面 OH 自由基積分面積從 2.07×10^7 提升至 4.22×10^7),因此表面摻雜比巨體摻 雜更可提高 TiO2 光催化活性。

Abstract

The aim of this study was to investigate the effects of bulk and surface lattice dopings on physicochemical properties and photocatalytic activities of V-doped TiO₂. sol-gel-derived TiO₂ exhibited 69.9 and 31.1 wt % of anatase and rutile phase, respectively. In addition, the crystallite size of the anatase TiO₂ was 6.1 nm. Lattice vanadium ions had no effect on crystal size of TiO₂, ranging between 6.0-6.5 nm. However, lattice vanadium ions completely inhibited the formation of rutile as the V/Ti ratio is as high as 1.27×10^{-3} . V₂O₅ crystals were observed on the surface of TiO₂ since vanadium ion diffused to surface when the calcination temperature was higher than its Tammann temperature. The UV-vis spectra show that bulk doping resulted in an additional absorption band centered at 289 nm. This phenomenon indicated that incorporation of V⁵⁺ ions into the bulk lattice of TiO₂ at low vanadium concentrations (V/Ti ratio < 1.00× 10⁻²) introduced extra energy levels in the conduction band. When V/Ti atomic ratio was higher than 1.00 %, some V⁵⁺ were partially reduced to V⁴⁺ which acted as charge recombination centers. Pure TiO₂ exhibited a rate constant of 5.20×10⁻² min⁻¹ for the photocatalytic degradation of Rhodamine B (RhB). Bulk doping decreased the photocatalytic activity to from 5.20×10⁻² to 1.50×10⁻² min⁻¹ when the V/Ti ratio increased from 4.41×10^{-5} to 1.22×10^{-2} . In addition, the integrated area of generated •OH on the surface of photocatalysts, which were calculated by EPR, decreased from 5.40×10^7 to 5.50×10^6 . The results indicated electrons diffuse to surface hardly. In contrast, surface doping had little effects on the micro- and electronic structures of TiO₂. Nevertheless, the photoactivity was enhanced from 5.20×10⁻² to 9.80×10⁻² min⁻¹ upon increasing vanadium concentration. The photoactivity of the surface doped TiO₂ was six times higher than that of bulk doped ones at the V/Ti ratio of 1.00×10^{-2} . Such enhancement is due to that surface-V⁵⁺ promotes diffusion of electrons to surface that further facility charges transfer to reactants. According to integrated area of surface doped materials, which increased from 2.07×10^7 to 4.22×10^7 , it indicate the electrons diffuse to surface efficaciously. Therefore, surface doping greatly improve the degradation efficiency, while bulk ones lad to detrimental effects on the photocatalytic activity.

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Chapter 1 Introduction

1-1 Motivation

Titanium dioxide (TiO_2) is the mostly used photocatalysts for decomposition of environmental pollutants because of cheap, nontoxic, and highly chemical stable characteristics¹. To improve its photocatalytic activity, impurities including transition metal ions (Fe, V)²⁻⁶ and non-metal ions (N, C)⁷⁻⁹ were doped into the TiO_2 lattice to modify its microstructures and electronic structures. The kinds of contributions of the modification to the photocatalytic activity include (1) inhibition of recombination by increasing the charge separation; (2) increase in the wavelength response range (i.e. excitation of wide band gap semiconductors by visible light); and (3) change in the selectivity or yield of a particular product. ¹⁰⁻¹²

The types and chemical states of dopants determine the microstructure, band gaps and photoactivity of metal-doped TiO₂ because of different electronic configurations and sizes of the ions. Panagiotis Bouras et al.⁴ reported Fe³⁺, Cr³⁺and Co²⁺ denoting visible-light photocatalyst were used to decompose Basic Blue 41, while photodegradation efficiency of the doped material was achieved only at very high doping levels. Kemp et al.¹³ reported that doping of rutile with Cr³⁺, V⁵⁺ or Mn²⁺ reduces its photoactivity, while doping with Mo⁵⁺ or W⁵⁺ enhances its photocatalytic performance. Martin et al.¹⁴ doped TiO₂ with V⁵⁺ via coprecipitation method which also resulted in reduced photoreactivity. However, Klosek and Raftrey¹⁵ reported V-doped TiO₂ extended the wavelength range of the catalyst into the visible region (396-450 nm) and greatly improved the photocatalytic activity of titania under solar light irradiation. However, the effects of vanadium ions on the photocatalytic activity of TiO₂ are still controversial.

Such uncertainties are attributed to the multiple oxidation states of vanadium ions (V^{3+} , V^{4+} and V^{5+}) which result in different nonstoichiometry and bandgaps of TiO_2 . In addition, the doping sites affect the bulk and surface crystalline structure, thereby controlling the utility of photo-generated charge carriers. Balikdjian et al. 16 reported that the presence of V species in the bulk lattice of anatase inhibited the transformation of anatase into rutile. Generally, anatase TiO_2 exhibits higher photocatalytic activity than rutile. In addition, the particle sizes of TiO_2 become small after doping with V^{5+} ions. 10 Large amounts of surface defects of the small sized photocatalyst promote the diffusion of charge carrier toward the surface and enhance photocatalytic activity. 17 18 However, the defects in the bulk lattice also could deeply trap charge carriers and inhibit charge diffusion as well as reduce photocatalytic

activity.

In contrast to deep trapping in the bulk, defects on the surface sites not only trap charge carriers but also deliver the trapped charges to adsorbed reactants. The trapping time of carrier electrons at the surface level become longer with an increase in $\triangle E_{surface}$ ($\triangle E_{surface}$ means the energy different LUMO of bulk TiO_2 and the lowest level of transition metal).¹⁹ Moreover, surface defects can cause unsaturated coordination of Ti^{4+} and oxygen vacancies which serve as active sites for photocatalysis.²⁰ Chang et al.²¹ reported Lewis acid sites of surface modified TiO_2 readily chemisorbed water to generate reactive hydroxyl radicals. In addition, electron transfer from conduction band to adsorbed O_2 was improved for efficient mediated photocatalysis. However, the effects of doping sites of vanadium ions on the physicochemical and photocatalytic properties have not been documented yet.

1-2 Objectives

This study aims to investigate the influence of bulk and surface doping sites on the micro-, electronic- structures and chemical states of V-doped TiO₂. The bulk and surface doped materials were prepared by sol-gel and surface sol-gel, respectively. In addition, the charge trapping and interfacial charge transfer properties were analyzed using EPR. The photocatalytic activities of the doped TiO₂ were determined in terms of decoloration of rhodamine B. The photocatalytic behavior of the doped TiO₂ with respect to its bulk and surface defects were discussed based on the physicochemical properties.

Chapter 2 Background and theory

2-1 TiO₂ semiconductor photocatalysts

2-1-1 Background and material properties

In 1972, Fujishima and Honda successfully found TiO₂ nanoparticles that can be used in photocatalytic reactors for degrading pollutions in water or air.²² Afterward, scientific studies on development and fabricate of photocatalysis by semiconductor was blossomed, which are listed in Table 2-1. In order to improve the efficiency of photoactivity, some surface modification methods have been proposed for the development of advanced photocatalysts, including composite semiconductors, surface sensitization, and transition metal doping.^{5,9,17} Nowadays, TiO₂ has been widely used in industrial application such as photocatalysis²³, solar energy cell²⁴, and gas sensors.²⁵

TiO₂ possesses a bandgap of 3.0-3.2 eV. Figure 2-1 shows the total density of electronic states of TiO₂. The conduction band (CB) and valence band (VB) of TiO₂ mainly consist of the Ti 3d and O 2p states, respectively. Generally, TiO₂ can be excited by energy in terms of heat or photon. The excited semiconductor has electrons and holes pairs within conduction and valence bands for further redox reactions, respectively. Thus, the principle of photocatalysis is the transformation of excited electrons and holes which play important roles in this system.^{17, 26}

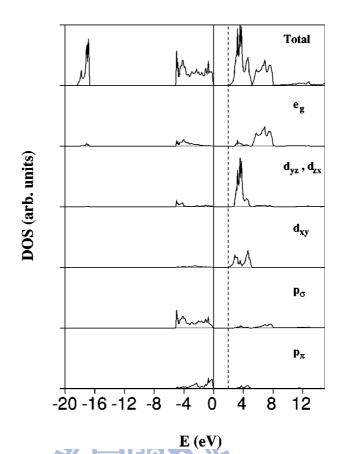


Figure 2-1 The density of electronic states of TiO₂. ²⁷

Table 2-1 Milestone of TiO₂-related studies.

Year	Authors	The results and findings	Ref.
1972	Fujishima et	First finding about electrochemical photolysis of water at a	
	al.	semiconductor electrode.	
1987	Matthews et	Photooxidation of organic impurities in water using thin	28
	al.	films of titanium dioxide.	
1994	Choi et al.	The summarization of metal-ion dopants in quantum-sized	29
		TiO_2 .	
1994	Martin et al.	Photochemical mechanism of quantum-sized	14
		vanadium-doped TiO ₂ particles	
1995	Linsebigler et	Mechanisms of photocatalysis of TiO ₂ , including surface	17
	al.	modification method.	
1999	Litter et al.	The mechanism of photocatalytic systems on transition	30
		metal ions doped in TiO ₂ .	
2002	Haber et al.	Surface doping of rutile by vanadium.	18
2003	Diebold et al.	The surface science of titanium dioxide.	31
2003	Weckhuysen	Chemistry, spectroscopy and the role of supported	32
	et al.	vanadium oxides in heterogeneous catalysis	
2004	Lee et al.	Electronic surface state of TiO ₂ electrode doped with	19
		transition metals, studied with cluster model and DV-X	
		alpha method	
2007	Xin et al.	The mechanisms of photoinduced carriers separation and	3
		recombination for Fe ³⁺ –TiO ₂ photocatalysts	

 TiO_2 has three types of crystalline structures: anatase, rutile, and brookite. At higher temperature above 623 K, anatase starts to transform to brookite and /or rutile, and then brookite transforms to rutile. At lower temperature below 623 K, the transformation between anatase and brookite may be reversible. The activation energy of transformation from anatase to brookite (11.9 KJ mol^{-1}) is much lower than that from brookite to rutile (163 KJ mol^{-1}). This means the brookite \rightarrow rutile transformation occurs under higher temperature, and proceeds rapidly (frequency factor is large). Figure 2-2 illustrates the variation of enthalpies of the three phases as a function of the particle size and Table 2-2 lists the range of crystal size on stable phase. If the crystal size of the three phases is equal, anatase can

transforms to brookite and then transforms to rutile.

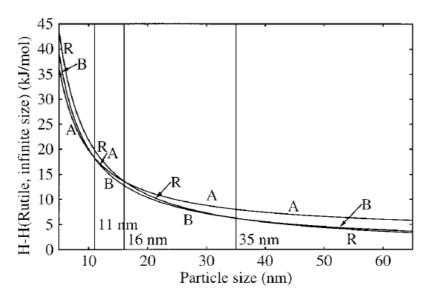


Figure 2-2 Variation of enthalpies of anatase, brookite, and rutile as a function of particle size. 33

Table 2-2 The relationship between crystal size and stable phase ³³.

Crystal size	Most stability phase
< 11 nm	Anatase Anatase
11 ~ 35 nm	Brookite
> 35 nm	Rutile

Figure 2-3 shows the crystalline structures of anatase and rutile TiO₂. Each Ti⁴⁺ ion is surrounded by an octahedron of six O²⁻ ions. In the rutile structure, each octahedron is in contact with 10 neighboring octahedrons (two sharing edge oxygen pairs and eight sharing corner oxygen atoms), while in the anatase structure each octahedron is in contact with eight neighbors (four sharing an edge and four sharing a corner). These differences in lattice structures cause different mass densities and electronic band structures between anatase and rutile.¹⁷ The octahedron in anatase is significantly distorted so that its symmetry is lower than orthorhombic. Therefore, anatase shows a higher adsorptive ability toward organic compounds²³ and lower rate of charge recombination³⁴, while rutile shows a lower bandgap energy and higher thermal stability.¹⁷

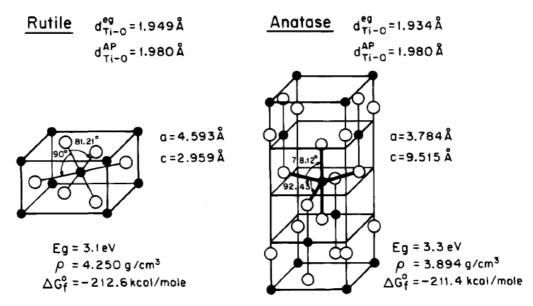


Figure 2-3 The crystal phases of TiO₂. ¹⁷

When the crystallite dimension of a semiconductor particle falls below a critical radius of approximately 10 nm, the band gap increases and the band edges shift to yield larger redox potentials, as shown in Figure 2-4. Thus, the size-quantized semiconductor TiO_2 particles may result in increased photo-efficiencies for systems in which the rate-limiting step is charge transfer. Figure 2-5 shows a high photo-reactivity of quantum-size TiO_2 due to the lack of band bending, while both electrons and holes are readily available at the interface (or vary close). However, size-quantized TiO_2 have been found to be less photoactive than their bulk-phase cases because surface speciation and surface defect density reduce photoactivity. Thus, the positive effects of increased over potentials (i.e., difference between E_{vb} and E_{redox}) on quantum yields could be offset by unfavorable surface speciation and surface defects due to the preparation method of size-quantized semiconductor particles.

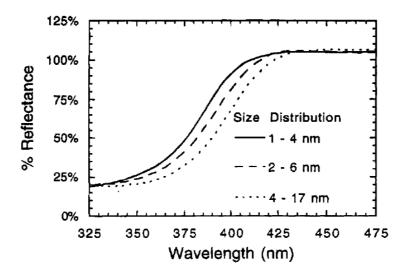


Figure 2-4 UV-Vis reflectance spectra of size-quantized TiO₂. ²⁶

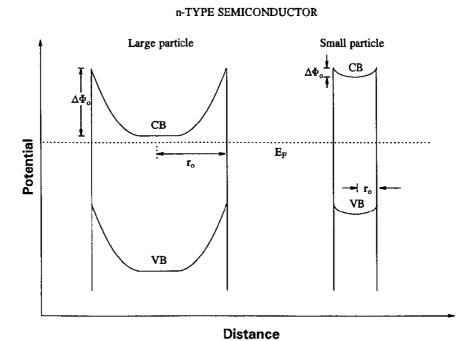


Figure 2-5 The formation of a space charge layer in a large and small semiconductor particle in equilibrium with a solution redox system.¹⁰

2-1-2 Principle of photocatalysis

Heterogeneous photocatalysis is one of the popular techniques for decontamination of air and wastewater, because photocatalyst can transform solar energy into chemical energy to degrade pollutants. The basic principles of heterogeneous photocatalysis can be simply summarized as follows. After the generation of charge carriers by absorbing UV-light with the energy over the band gap, the charge carriers undergo trapping, recombination, detrapping, and migration to the surface, as seen in Figure 2-6. 14, 26, 29

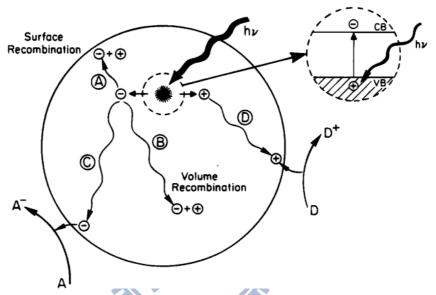


Figure 2-6 Schematic photoexcitation in a solid followed by deexcitation events. 17

Figure 2-7 shows the basic transitions in a semiconductor, including intrinsic and extrinsic transitions. When the semiconductor is irradiated with UV light, photons are absorbed to create electron-hole pairs while the photon energy (hv) is equal to or larger than the bandgap energy (E_g). If hv is greater than E_g , excess energy is dissipated as heat, as shown in Figure 2-7 (b). These processes are called intrinsic transitions or band-to-band transitions. In addition, for hv is less than E_g , a photon will be absorbed by energy states which are created by chemical impurities or physical defects. Above performance is defined extrinsic transition, as shown in Figure 2-7 (c). 35

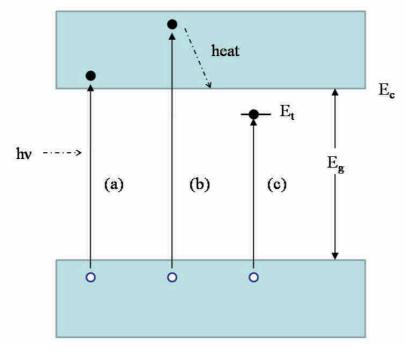


Figure 2-7 Optical absorption for (a) $hv = E_g$, (b) $hv > E_g$, and (c) $hv < E_g$.³⁵

For thermodynamic view point, the band energy positions and the redox potential of semiconductors determine the ability of charge transfer to acceptors. Adsorbed pollutants can be reduced by conduction band (CB) electrons if they have redox potential more positive than the V_{fb} of the CB. Besides, the pollutants can also be oxidized by valence band (VB) holes if they have reduction potential more negative than the V_{fb} of the VB. Figure 2-8 shows the band edge positions for various semiconductors. Left axis presents the internal energy scale relative to the vacuum level and right one shows the comparison with normal hydrogen electrode (NHE). The positions are originated from the flat band potentials in a contact solution of aqueous electrolyte at pH = 1. Therefore, more pollutants can be decomposed in case the band gap is larger.

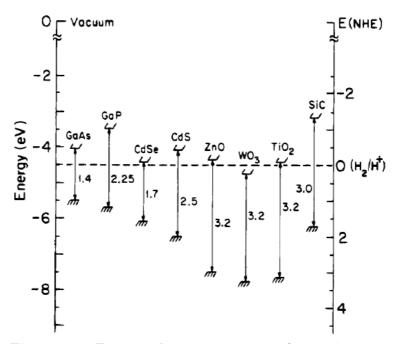


Figure 2-8 The energies for various semiconductors in aqueous electrolytes at pH = 1.¹⁷

Figure 2-9 shows the time scale of charge carrier generation, trapping, recombination, and interfacial transfer. After charge-carrier generation (~fs), recombination is mediated primarily by Ti³⁺ in the first 10 ns. Valence-band holes are sequestered as long-lived TiOH⁺ after 10 ns. TiOH is reformed by recombination with conduction band electrons or oxidation of the substrate on the time scale of 100 ns. However, the electrons transfer from CB to surface is micro-seconds, so the phenomena is determine step in photocatalysis.²⁶

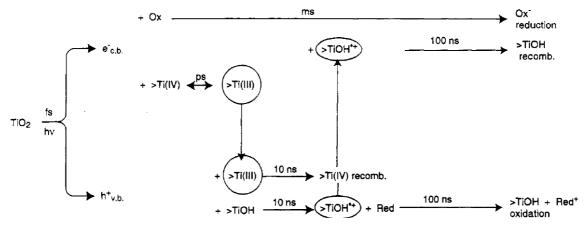


Figure 2-9 Kinetics of the primary steps in photoelectrochemical mechanism. Where TiOH represents the primary hydrated surface functionality of TiO_2 , e_{cb}^- is a conduction-band, e_{tr}^- is a trapped conduction band electron, h_{vb}^+ is a valence band hole, Red is an electron donor (i.e., reductant), Ox is an electron acceptor (i.e., oxidant),

 $[{\rm Ti}^{4+}{\rm OH}^{\bullet}]^{+}$ is the surface-trapped valence band (VB) hole (i.e., surface-bound hydroxyl radical), and $[{\rm Ti}^{3+}{\rm OH}]$ is the surface-trapped conduction band (CB) electron. And the arrow lengths are representative of the respective time scales.

Hoffmann et al. 26 and Hurum et al. 37 reported that the photogenerated holes recombine with surface electrons easily. So, the present of oxygen not only act as an electron acceptor, but also perform H_2O_2 which is a direct source of hydroxyl radicals. 26 Besides, the hydroxyl radical (\bullet OH) was proposed to be the primary oxidant in the degradation of organic water contaminants. 38,39 Therefore, the processes of secondary reactions with activated oxygen are summarized in Figure 2-10. Figure 2-10 shows the oxidation occur by either oxidation via the surface-bound hydroxyl radical (i.e., trapped hole at the TiO_2 surface) or via the other radicals (i.e., formation of superoxide radicals). And the reduction occurred by directly electrons diffusion under lower conduction states of TiO_2 . Hence, it is important for the present of oxygen which plays as the primary electron acceptor. 39

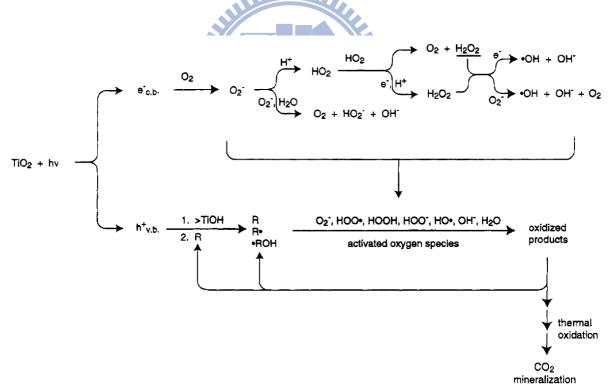


Figure 2-10 Secondary reactions with activated oxygen species in the photoelectrochemical mechanism.²⁶

2-1-3 Photoassisted degradation of Rhodamine B

In general, the TiO₂ degrade many organic pollutants and to mineralize completely under In order to expand the wavelength range in visible light for the UV irradiation.^{26, 40} photocatalysts, surface sensitization of TiO₂ via chemical or physic adsorbed dyes molecular were used to promote the efficiency of the charge carrier separation with visible irradiation.^{12,} For example, the chemisorbed RhB is excited at wavelengths longer than 470 nm to produce singlet and triplet states (denoted here simply as RhB*_{ads}). Subsequently, RhB*_{ads} injects an electron into the conduction band (or to some surface state) of TiO₂ with RhB being converted to the radical cation RhB^{*+}, as shown in Figure 2-11. Afterward, the electrons in the conduction band of TiO₂ react with adsorbed oxidants, usually O₂, to produce reactive oxygen radicals (Equation 2-3 to 2-6). Figure 2-12 shows the de-ethylation reaction since the radical cation RhB⁺⁺ ultimately reacts with reactive oxygen radicals and/or molecular oxygen. 40 Moreover, oxygen plays an additional important role to inhibit recombination between RhB*+ and e-CB. In addition, the secondary radical processes occurred might lead to mineralization. The semiconductor TiO₂ acts as an electron-transfer mediator and the oxygen as an electron acceptor leading to efficient separation of the injected electron and the radical cation, thereby facilitating the degradation process.

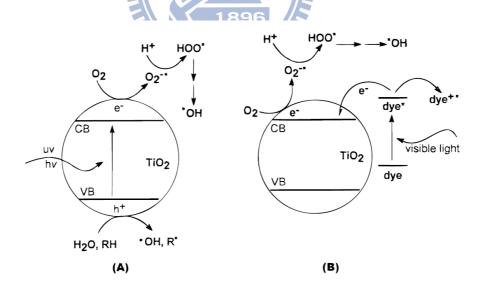


Figure 2-11 Electron-transfer processes (a) for UV irradiation of TiO₂ with the self-photosensitized pathway (b) under visible light irradiation which subsequent to excitation of RhB dye.⁴⁰

$$Dye_{ads} + h\upsilon \to Dye_{ads} * \tag{2-1}$$

$$Dye *_{ads} + TiO_2 \rightarrow Dye_{ads}^{\bullet +} \qquad \qquad E^{\circ} = -1.09 \text{ V}$$
 (2-2)

$$TiO_2(e^-_{cb}) + O_2 \rightarrow O_2^{\bullet -}$$
 E°= -0.33 V (2-3)

$$O_2^{\bullet-} + H^+ \rightarrow OOH^{\bullet}$$
 $E^{\circ} = -0.037 \text{ V}$ (2-4)

$$OOH^{\bullet} + O_2^{\bullet-} + H^+ \rightarrow O_2 + H_2O_2$$
 $E^{\circ} = +1.84 \text{ V}$ (2-5)

$$H_2O_2 + O_2^{\bullet-} + H^+ \to OH^{\bullet} + OH^- + O_2$$
 $E^{\circ} = +0.74 \text{ V}$ (2-6)

$$Dye_{ads}^{\bullet+} + (OH^{\bullet}, O_2^{\bullet}, and/or O_2) \rightarrow \rightarrow$$

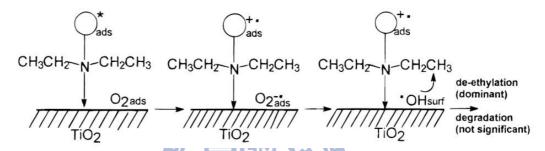


Figure 2-12 Formation and competitive reactions of •OH radicals during visible light irradiation of Rhodamine B.²²

2-2 Synthesis toward metal oxide

2-2-1 Sol-gel method

Sol-gel processes have been widely used to synthesize TiO₂, because there are many advantages of the sol-gel processes include cheaper, low reaction temperature, uniform structure, extreme purity, selective of precursor and widely applications. The sol-gel process can be characterized by a series of distinct steps.⁴¹

- Step 1: In order to stable solutions of the alkoxide or solvated metal precursor (the *sol*), so the precursor would under hydrolysis and condensation for couple days.
- Step 2: After hydrolysis and condensation, gelation resulting from the formation of an oxideor alcohol-bridged network (the *gel*) by a polycondensation or polyesterification reaction that results in a dramatic increase in the viscosity of the solution. If so desired, the gel may be cast into a mold during this step.
- Step 3: Aging of the gel (syneresis), during which the polycondensation reactions continue

until the gel transforms into a solid mass, accompanied by contraction of the gel network and expulsion of solvent from the gel pores. Ostwald ripening and phase transformations may occur concurrently with syneresis. The aging process of gels can exceed 7 days and is critical to the prevention of cracks in gels that have been cast.

- Step 4: Drying of the gel, to remove water and other volatile liquids from the gel network. This process is complicated due to fundamental changes in the structure of the gel, which was occurred between 100 and 180 °C. If isolated by thermal evaporation, the resulting monolith is termed a *xerogel*. If the solvent is extracted under supercritical or nearsupercritical conditions, the product is an *aerogel*.
- Step 5: Dehydration, during which surface-bound M-OH groups are removed, thereby stabilizing the gel against rehydration. This is normally achieved by calcining the monolith at temperatures up to 800°C. Besides, the calcination processes also cause crystal structure of materials to produce.

Figure 2-13 shows the reaction of sol-gel, including hydrolysis, condensation, and gelation. The hydrolysis occurs by the nuclephilic attack of the oxygen contained in water on the silicon atom as evidenced by the reaction of isotopically labeled water with TEOS that produces only unlabelled alcohol in both acid and basic catalyzed system. Besides, the polymerization to form siloxane bonds occurs by either an alcohol producing condensation reaction or a water-producing condensation reaction. Relative to different condition (i.e. pH), the typical of condensation products is monomer, dirmer, linear trimer, cyclic tetramer and higher-order rings. In basic condition, particle growth in size with decrease in number; in acid condition, the particles aggregate into three-dimensional networks and form gel. So, the structure was linear or randomly branched polymer under acid condition, while it was branched cluster under basic condition. And the final process is drying and calcination which lead to the structure of gels stable by thermal treatment.⁴¹ In addition, Figure 2-14 shows the processing steps involved in making sol-gel-derived.

(a) Hydrolysis

OR OH
$$\mid$$
 OH \mid OH OH OH + 4HOR \mid OR OH OH OH OH OH OH

(b) Condensation

OH OH OH OH OH
$$\mid$$
 \mid \mid \mid \mid OH OH + OH — M — OH — M — O — M — OH + HOH \mid OH OH OH OH

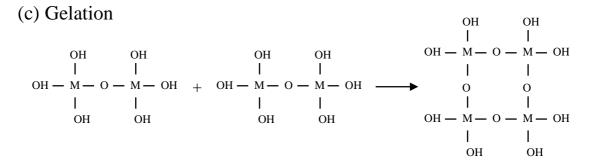


Figure 2-13 The process of sol-gel under acid condition. (a)Hydrolysis, (b)Condensation, and (c)Gelation.⁴¹

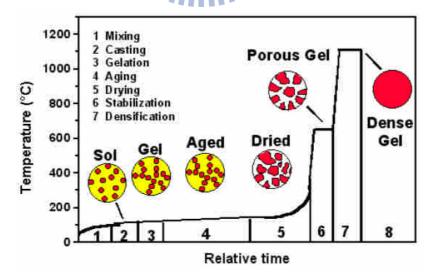


Figure 2-14 Gel process sequence. 42, 43

Generally speaking, the transition metal systems are distinguished from silicates by greater chemical reactivity resulting from the lower electronegativity of the metal and its

ability to exhibit several coordination states, so that coordination expansion occurs spontaneously upon reaction with water or other nucleophilic regents.⁴⁴ Therefore, the sol-gel processes of silicon and titanium precursors were similar, silicon was used to make example in this study. Sol-gel processes appear to be a simple operation, but several variables can influence the properties of the final products. Such as, pH of the reaction medium, water: alkoxide ratio, reaction temperature, and polarity of solvent. Therefore, by varying these processing parameters, materials with different physicochemical properties can be obtained. Thus the different parameters were introduced below.

The introduction of water to the Si(OR)₂ precursor initiates hydrolysis, as shown in Figure 2-15. The water:alkoxide ratio determines the sol-gel chemistry and the structural characteristics of the hydrolyzed gel. High water:alkoxide ratios in the reaction medium ensure a more complete hydrolysis of alkoxides, favoring nucleation versus particle growth. Thus precursor solution reacts very quickly with water especially in the presence of excess of water. The rapid initial hydrolysis results a solution with a high degree of supersaturation of hydroxylated metal oxide. This leads to a high rate of nucleation and the formation of small particles or crystallites.^{44,45}

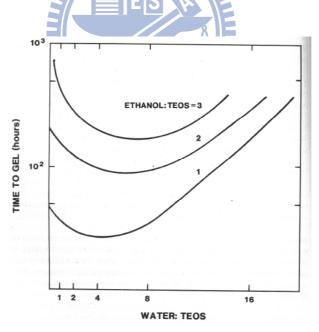


Figure 2-15 The relationship between gelation times and H₂O:alkoxide ratio.⁴⁴

Whether the hydrolysis is acid or base catalyzed also has important consequences for the structure of the resulting gel network. For acidic conditions (pH < 4), the rate of hydrolysis will always exhibit faster kinetics than the rate of condensation due to the ability of -OR groups to better stabilize the transition states. Besides, the gelatin process was delayed in

the synthesis with HCl addition, so that a turbid gel was formed instead of white precipitates. HCl serves not only as an acid catalyst, but also as an electrolyte to prevent particle growth or agglomeration through electrostatic repulsion. Besides, under basic conditions, the silica products tend to form large agglomerates that eventually cross-link. Therefore, the differences between acid and base catalyzed reactions and the consequences for particle morphology are conceptually represented in Figure 2-16.

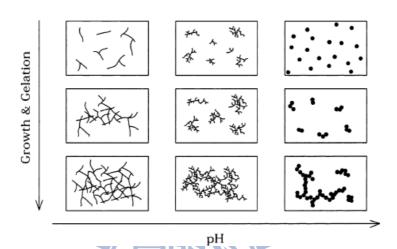


Figure 2-16 The different structure of particles depend on pH.⁴¹

The polarity of solvent affects the hydrolysis process, because the hydrolysis reaction proceeds via nuclephilic reaction mechanism with OH as the nucleophile. This phenomenon facilitate further attack of the nuclephile on the silion atom which is more positive charge on the silicon atom after the hydrolysis of the first alkoxy group, because OH is a marginally better leaving group than –OR while the condensation process can occur. Thus, the rate of hydrolysis and condensation reaction followed sequence 1-butanol > methanol > 1-propanol > ethanol > 2-propanol, because the reaction rate was caused by hydrogen bonding and steric effect in solvent alcohol. If the hydrogen bonding ability is the only one factor, then increasing hydrogen bonding ability of solvent decreases the mobility of water to react with TEOS while the rate of hydrolysis reaction followed order 1-butanol > methanol > 1-propanol > ethanol > 2-propanol. 47,48 However, in order to slow down the rate of hydrolysis, 2-propanol is the better chose for solvent.

2-2-2 Surface sol-gel method

In addition to sol-gel method, surface sol-gel can fabricate ultra-thin films with molecular-scale. Figure 2-17 shows the process of surface sol-gel. This process is

composed of chemisorption of alkoxide, rinse, hydrolysis of the chemisorbed alkoxides, and drying.^{44, 49} The moving substrate entrains liquid in a fluid mechanical boundary layer carrying g some of the liquid toward the deposition region, where the boundary layers splits in two (see Figure 2-18). The inner layer moves upward with the substrate, while the outer layer is returned to the bath. The thickness of the deposited film is related to the position of the streamline dividing the upward- and downward-moving layers.

Therefore, there are six forces in the film deposition region govern the film thickness and position of the streamline: (1) viscous drag upward on the liquid by the moving substrate, (2) force of gravity, (3) resultant force of surface tension liquid in the concavely curved meniscus, (4) inertial force of the boundary layer liquid arriving at eh deposition region, (5) surface tension gradient and (6) the disjoining or conjoining pressure (important for films less than 1 µm thick). When the liquid viscosity and substrate speed are high enough to lower the curvature of the meniscus, then the deposited film thickness balances the viscous drag and gravity force.⁴⁴

According to surface sol-gel principle, the process could be applied to various materials surfaces irrespective of their shape, size and structure. Besides, it is applicable to a wide range of metal precursor (metal alkoxides). Therefore, the reaction between the surface TiO₂ hydroxyl groups with vanadia precursor molecules is therefore the best route to obtain well-defined surface concentrations of vanadium. However, Figure 2-19 shows the structure of production was prepared with different path way.

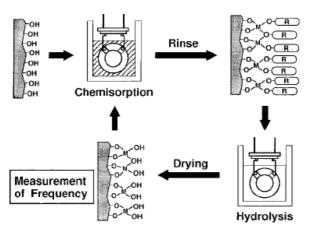


Figure 2-17 Schematic representation of the surface sol-gel process.⁴⁹

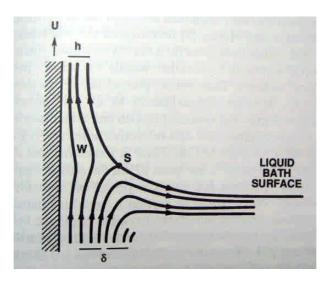


Figure 2-18 Detail of liquid flow patterns of the containous process. U is the withdrawal speed, S is the station point, δ is the boundary layer, and h is the thickness of the fluid film.⁴⁴

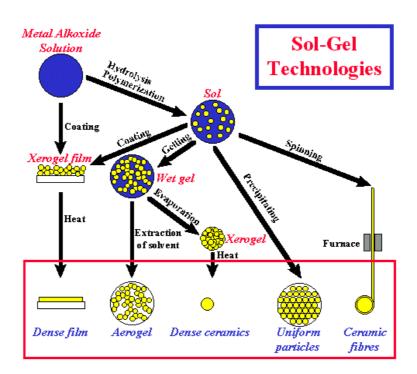


Figure 2-19 The production prepared by sol-gel-derived with different processes. 42, 44

2-3 Doping TiO₂ with impurities

Photocatalytic activity of a particular semiconductor system for the stated purpose is measured by several factors including the stability of the semiconductor under irradiation, the efficiency of the photocatalytic process, the selectivity of the products, and the wavelength range response. Therefore, photocatalyst for a particular use can be surmounted by modifying the surface of the semiconductor. Three benefits of modifications to

photocatalytic semiconductor systems have been studied: (1) inhibiting recombination by increasing the charge separation; (2) increasing the wavelength response range (i.e. excitation of wide band gap semiconductors by visible light); and (3) changing the selectivity or yield of a particular product. For examples, impurities like transition metal ions (Fe, V)^{2-5, 50}, and non-metal ions (N, C)⁷⁻⁹ were mostly used to dope into crystalline structure of TiO_2 to vary some physicochemical properties of original TiO_2 , including microstructure, electronic structure, and photocatalysis.

In order to define the structure of vanadium doped in TiO_2 , the catalysts have been studied by in situ FT-Raman. Figure 2-20 and Figure 2-21 show the structure of surface and bulk doped materials. For surface doped materials, there are two kinds of forms of VO_x species attached to the TiO_2 surface: monomeric vanadyl and polymeric vanadates. In particular, the coordination of the surface oxygen atoms plays a key role in reactivity. All of the potentially active oxygen sites proposed to be vanadyl V=O (1030 cm⁻¹), bridging V-O-V (822 cm⁻¹), interface V-O-Ti, and surface Ti-O-Ti (638 cm⁻¹). For hydrogen atomic adsorption, the most reactive sites are those located at the interface between the V_2O_5 and the TiO_2 unit (V-O-Ti), while the vanadly V=O bonds are more stable. So, while the number of vanadium centers in the polyvanadates increase, the number of terminal V=O (930 cm⁻¹) groups per vanadium decreases to accommodate V-O-V (822 cm⁻¹) linkages. It meant the vanadium ions were preferred to perform V_2O_5 under higher vanadium concentration. For bulk doped materials, the V^{4+} ions were substituted Ti^{4+} of TiO_2 structure, because two cations have the similar ionic charge ($rV^{4+}_{6c} = 0.590$ Å and $rTi^{4+}_{6c} = 0.605$ Å).



Figure 2-20 The structure of surface doped materials.⁵²

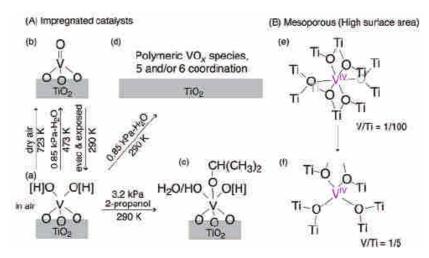


Figure 2-21 Proposed V site transformations for V/TiO₂ in surface doped materials (A) and for bulk doped materials (B). [H] for models a and c indicates the presence/absence of hydrogen cannot be determined.⁵⁵

Figure 2-22 shows the bonding diagram of the TiO_2 perfect crystal (rutile). The conduction band (CB) and valence band (VB) of TiO_2 mainly consist of the Ti 3d and O 2p states, respectively. Besides, the bottom of the lower CB consisting of the T d_{xy} orbital contributes to the metal-metal interactions due to the σ bonding of the Ti t_{2g} – Ti t_{2g} states.⁵⁶ Therefore, if transition metal ions doped in TiO_2 , the bandgap energy of TiO_2 shifted a lower energy due to extra energy level caused by 3d dopants (transition metal ions).⁵ So, in case of V/TiO₂, total density of electrons is shown in Figure 2-23. The V^{5+}/V^{4+} redox level was lied 1.4 eV above the top of the valence band in rutile. The V^{4+}/V^{3+} level lies 0.8 eV below the bottom of the conduction band.^{29,57} While both redox levels remain with the band gap in the TiO_2 colloids, both holes and electrons can be trapped by V^{4+} which will cause disappearance of the V^{4+} EPR signal.^{29,57}

In order to define hyperfine parameter of various species containing a V^{4+} paramagnetic ion, I have used subscripts 6c, 5c and 4c to stand hexa-, penta-, and tetracorrdinated V^{4+} species. In this notation, vanadyl ions are formally labeled $(VO^{2+})_{ic}$ were referred to the global vanadium coordination. However, three are three distinct ligand field geometries can thus be distinguished, as shown below.⁵⁸

- 1. Vanadly ions in a square pyramidal $(VO^{2+})_{5c}$ or in an axially distorted octahedral symmetry $(VO^{2+})_{6c}$. (g = 1.955 ~ 1.980)
- 2. Vanadium ions in a tetrahedral geometry, $(V^{4+})_{4c}$.
- 3. Vanadium ions in a biaxially distorted octahedral symmetry, $(V^{4+})_{6c}$. $(g = 1.920 \sim$

Moreover, the coordination sphere of these vanadyl ions (VO^{2+}) may then be completed either by some surface oxygen anions (O^{2-}) of the TiO_2 sublattice or by adsorbed water molecules. And $(V^{4+})_{6c}$ is shown a vanadium ions located at the center of the rutile unit cell is surrounded by a slightly distorted oxygen octahedron.⁵⁸

In addition, the atomic ratio of V/Ti can influence the electronic structure. Figure 2-24 shows the band model of $Ti_{1-x}V_xO_2$ at bias potential of 1V vs. SCE in an electrolyte solution at various atomic ratio of V/Ti. For V/Ti = 0.025 and 0.05 samples, the recombination time was larger than V/Ti=0 sample, because the V 3d level in the bandgap inhibited the electron-hole recombination. But, it seemed the increasing photocurrent with the potential was stronger for V/Ti \geq 0.1 samples. This can probably be ascribed to the connection of the filled V 3d level with the conduction band, which result in the semi-metal behavior. Summary, the different atomic ratio of V/Ti can influence the electronic structure of materials.

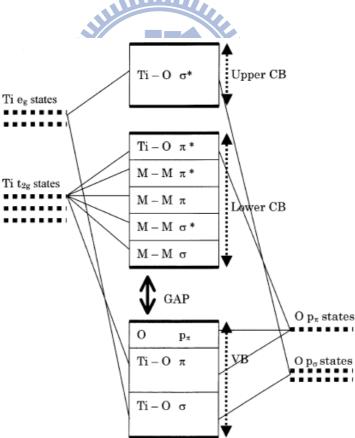


Figure 2-22 The bonding diagram of the TiO_2 perfect crystal (rutile) proposed by Soratin and Schwarz.^{5, 56}

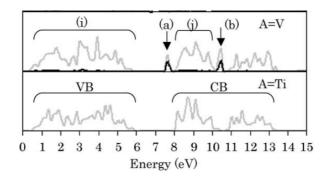


Figure 2-23 The DOS of metal-doped TiO_2 ($Ti_{1-x}A_xO_2$: A=V or Ti). Gray lines means total DOS and black lines shows dopant's DOS.⁵

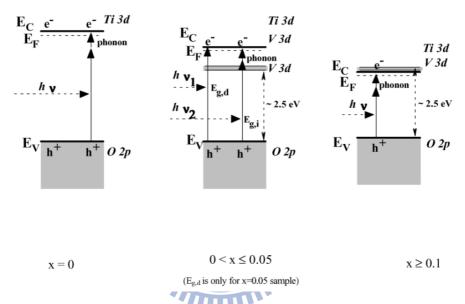


Figure 2-24 Band model of $Ti_{1-x}V_xO_2$ film electrodes at bias potential of 1 V vs. SCE in an electrolyte solution.⁵⁹

The extra energy caused by dopant affect photocatalysis of TiO₂ because the defect performed by dopants can trap either an electron or a hole alone.²⁹ So, a general photochemical charge-trapping, recombination, detrapping, and migration mechanism in the presence of transition metal ion dopants is proposed as Figure 2-25:

charge pair generation

$$TiO_2 + h\nu \rightarrow e_{cb}^- + h_{vb}^+$$
 $M^{n+} + h\nu \rightarrow M^{(n+1)+} + e_{cb}^ M^{n+} + h\nu \rightarrow M^{(n-1)+} + h_{vb}^+$

charge trapping

$$Ti^{4+} + e_{cb}^{-} \rightarrow Ti^{3+}$$
 $M^{n+} + e_{cb}^{-} \rightarrow M^{(n-1)+}$
 $M^{n+} + h_{vb}^{+} \rightarrow M^{(n+1)+}$
 $>OH^{-} + h_{vb}^{+} \rightarrow >OH^{-}$

charge release and migration

$$M^{(n-1)+} + Ti^{4+} \rightarrow M^{n+} + Ti^{3+}$$

 $M^{(n+1)+} + > OH^{-} \rightarrow M^{n+} + > OH^{\bullet}$

recombination

$$e_{cb}^{-} + h_{vb}^{+} \rightarrow TiO_{2}$$
 $Ti^{3+} + > OH^{\bullet} \rightarrow Ti^{4+} + > OH^{-}$
 $M^{(n-1)+} + h_{vb}^{+} \rightarrow M^{n+}$
 $M^{(n-1)+} + > OH^{\bullet} \rightarrow M^{n+}$
 $M^{(n+1)+} + e_{cb}^{-} \rightarrow M^{n+}$
 $M^{(n+1)+} + Ti^{3+} \rightarrow M^{n+}$

interfacial charge transfer

$$e_{cb}^{-}$$
 (or Ti³⁺, M⁽ⁿ⁻¹⁾⁺) + O \rightarrow O⁻
 h_{vb}^{+} (or >OH*, M⁽ⁿ⁺¹⁾⁺) + R \rightarrow R⁺

Where Mⁿ⁺ is a metal ion dopant, O is an electron acceptor (oxidant), and R is an electron donor (reductant).

Figure 2-25 The photochemical mechanism in the present of transition metal ions.²⁹

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It has hypothesized that the addition of transition metals to titania increases the rate of photocatalytic oxidation, due to the electron scavenging by the transition metal ions at the semiconductor surface through the following reaction: $M^{n+} + e^-_{CB} \rightarrow M^{(n-1)+}$, where M^{n+} represents transition metal ions. This reaction prevents electron-hole recombination and results in an increase rate of formation of \bullet OH radical. Besides, when dopant acts as both electrons trapping and holes trapping, it would decrease the rate of recombination. For example, the present of vanadium in the TiO_2 lattice act as both electrons and holes trapping. Thus, the photoactivity of V^{5+} is significantly higher than the photoactivity of V^{4+} . So

2-4 Bulk and surface doping sites

Lee et al. reported¹⁹ that the surface levels of TiO₂ were the levels of mixed orbitals, which are composed of 3d orbitals of Ti and 2p orbitals of the surface oxygen. Therefore, the electronic density of bulk and surface are different, which is shown in Figure 2-26. The effect of vanadium doping positions on the electronic structure of TiO₂ could be different. Most of the dopant levels related to the surface are found between conduction and valence bands of bulk TiO₂. Therefore, it is expected that the doping of a transition metal to a TiO₂ surface increases the surface trapping rate of carrier electrons and the trapping effect becomes larger with increasing in the atomic number of a transition metal dopant. Lee et al. 19 reported that the number and energy of surface levels are deeply affected by impurities found on the surface of TiO2. And the trapping time of carrier electrons at the surface level become longer with an increase in $\triangle E_{surface}$. ($\triangle E_{surface}$ means the energy different LUMO of bulk TiO₂ and the lowest dopant level). It refers that transition metal doped on TiO₂ surface increases the surface trapping rate of carrier electrons. However, the bulk doping site caused by transition metals performed extra energy level between VB and CB. Although the defects retard the charge recombination by trapping, the trapped electrons/holes can not migrate to substance surface for following reduction or oxidation of adsorbed reactants. Thus, the surface doping sites can promote the electrons to transfer to surface efficiently, while bulk doing sites could be detrimental to the photocatalytic activity. However, there are few papers to discuss the mechanism of photocatalysis with different V-doping positions.

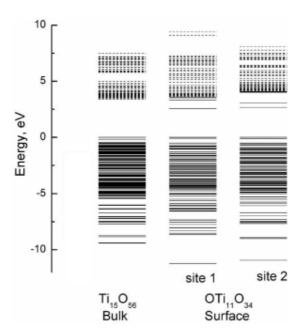


Figure 2-26 The energy level diagram calculated using large cluster models of $(Ti_{15}O_{56})^{52-}$ and $(Ti_{11}O_{34})^{24-}O^*$ corresponding to the bulk and surface of rutile TiO_2 . ¹⁹

Doping TiO_2 with V^{4+}/V^{5+} at different sites also influences the crystal structures. Balikdjian and Davidson et al¹⁶ reported that the presence of V species into the bulk lattice of anatase did not affect the transformation of anatase into rutile, but the V species deposited on the surface of anatase grain boundary favored rutile transformation. In addition, the particle sizes of TiO_2 become small after doping with V^{5+} ions and result in significant band bending.

To fully understand the influence of doping on the nature and extent of charge transfer, particle size and crystal structure need to be investigated.

In heterogeneous system, the photoactivity occurs on the surface of materials. The defects on the TiO₂ surface are easily formed by thermal treatment because the oxygen vacancy site leaves an exposed Ti³⁺ ion which may be visualized as a Ti⁴⁺ ion associated with a somewhat localized electron. In addition, the exposed Ti³⁺ atoms diffuse from the bulk to the surface during calcination, so the thermal treatment causes the incorporation of oxygen vacancy into the surface layer of TiO₂. Surface trapping sites were supposed to promote the photocatalytic activity efficiency than bulk trapping sites due to a lack of surface oxygen defects. Figure 2-27 shows bulk and surface trapping sites, respectively. The electrons trapped by bulk defect called bulk trapping, and the electrons trapped by surface defect called surface trapping. However, there are too less papers to discuss the difference between bulk and surface doping sites on physiochemical properties of V-doped materials.

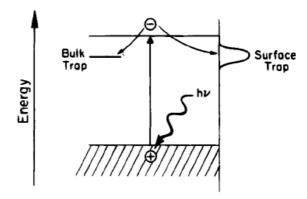


Figure 2-27 Surface and bulk electron carrier trapping. 17



Chapter 3 Materials and methods

Figure 3-1 shows the flow chart of the experimental design in this study. Catalysts are synthesized with sol-gel and surface sol-gel methods.

3-1 Materials

Titanium isopropoxide (TTIP, Acros, 98 %+) and vanadium (V) oxytriisopropoxide (VTIP, Aldrich, 99 %+) were used as the precursors of titania and vanadium, respectively. 2-propanol (C₃H₇OH, J.Backer, 100 %) was used as solvent to dissolve titanium isopropoxide and vanadium (V) triisopropoxide. Rohdamine B (RhB, C₂₈H₃₁N₂O₃Cl, Sigma Aldrich, Dye content 95 %) was used as the target compound for photocatalysis and its structure is shown in Figure 3-2. Hydrogen acid (HCl, Crown, 35 ~ 37 %) was used to adjust the pH of sol solution to slow down the hydrolysis. Filter membrane (Critical, 47 mm in diameter, 0.2 μm in pore size) was used as a support for the TiO₂ during its surface coating process. 5,5-dimethyl-1-pyrroline N-oxide (DMPO, Aldrich, 97%, d= 1.05 g/mL) was used as a •OH trapped agent. The original DMPO solution was stored at – 25 °C. In addition, DMPO diluted by DI water were decay, so the solution need to use immediately for least 2 two days stored at 4 °C.

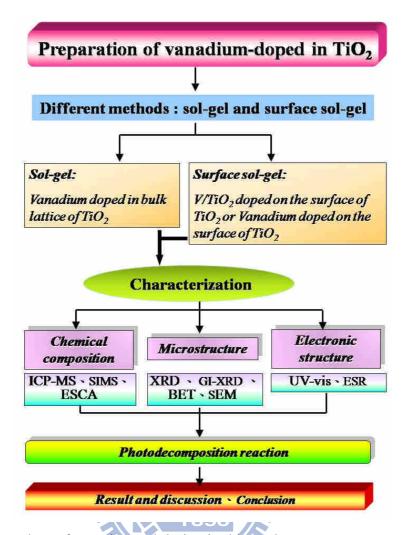


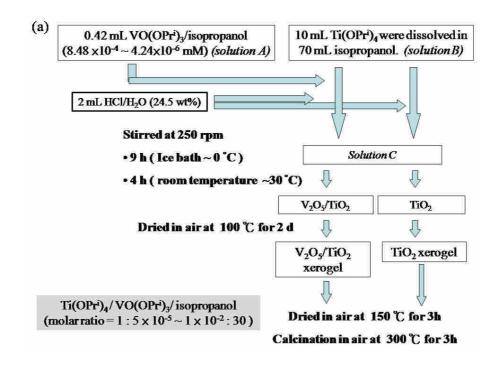
Figure 3-1 Flow chart of experimental design in this study.

Figure 3-2 The chemical structure of RhB.

3-2 Preparation of bulk doped TiO₂ via sol-gel process

Figure 3-3 shows the preparation procedure for bulk doped TiO_2 . Firstly, TTIP and VTIP were dissolved in 70 mL isopropanol in sample vials (110 mL) to reach various V/Ti atomic ratios ($1 \times 10^{-5} \sim 1 \times 10^{-2}$). Then, 2 mL hydrogen chlorate acid (24.5%, HCl) was injected into the mixtures at 4°C with stirring at 250 rpm. The solutions were maintained at this temperature for 9 h to complete the hydrolysis of TTIP and VTIP. Afterward, the solutions underwent gelation at room temperature for 4 h. The doped TiO_2 powders were obtained through evaporating solvent at 100°C for 2 d followed by 150°C for 3 h. The solids were then calcined under air at 300 °C for 3 h. The resulting xerogels were called VT.





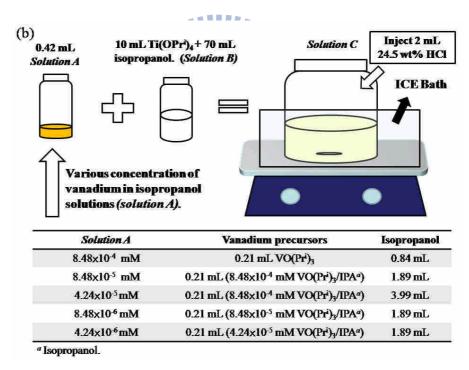
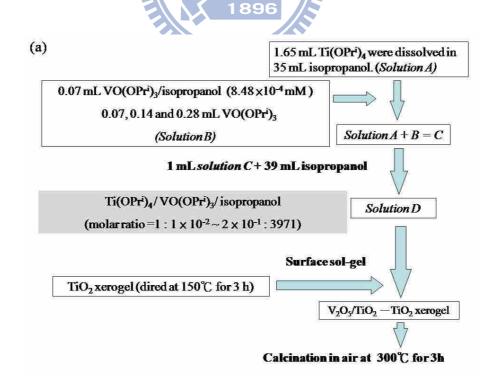


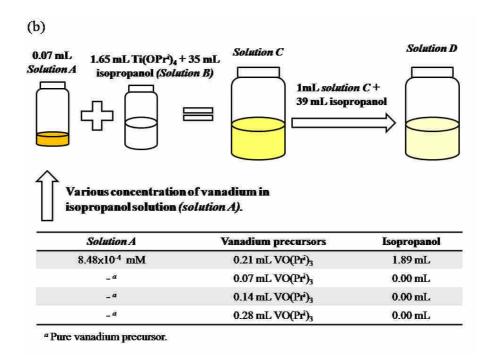
Figure 3-3 The synthetic process of bulk doped materials. (a) the flow charts of the synthesis and (b) the recipes of precursor solutions.

3-3 Preparation of surface doped TiO₂ via surface sol-gel process

Figure 3-4 shows the preparation procedure for surface doped TiO₂. Surface doped materials were prepared via coating a thin V-doped TiO₂ layer onto TiO₂ using surface sol-gel process. Figure 3-5 shows the carton and photograph of surface sol-gel system. Moreover, the dried TiO₂ powders were obtained through evaporating solvent at 100° C for 2 d followed by 150° C for 3 h. The dried TiO₂ powders were stood between Teflon and filter paper, which were immersed in shallow container filled with *solution D*. And the *solution D* at different TTIP/VTIP atomic ratios was prepared as following: Firstly, TTIP and VTIP were dissolved in 35 mL isopropanol to reach varies VTIP/TTIP atomic ratios $(1 \times 10^{-2} \sim 2 \times 10^{-1})$. Then, 1 mL of above mixing solution (*solution C*) was injected into 39 mL isopropanol for dilution, and the diluted solutions were named *solution D*, as shown in Figure 3-4.

The dried TiO_2 powders were immersed in *solution D* about 10 minutes. Then the dried TiO_2 were raised by hand and then the powders were separated from diluted precursor by gravity. Afterward, the solids were dried at 100 °C for few minutes and then were calcined at 300 °C for 3 h. The resulting xerogels obtained were named SVT. In addition, the pure V_2O_5 coated on the surface of TiO_2 were named SVTP, which was shown in Appendix F. To summary the structures of bulk doped and surface doped TiO_2 , Figure 3-6 shows the three type materials in this study.





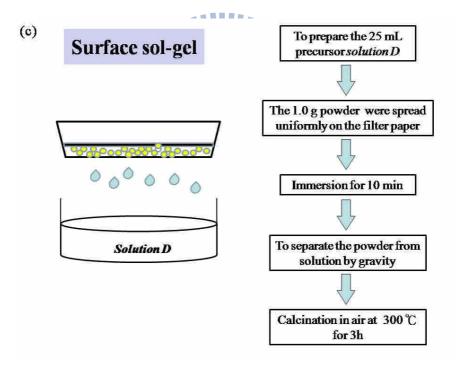


Figure 3-4 The synthetic process of surface doped materials. (a) the flow charts of the synthesis of surface doped materials, (b) the recipes of precursor solutions, and (c) the surface sol-gel processes for coating.

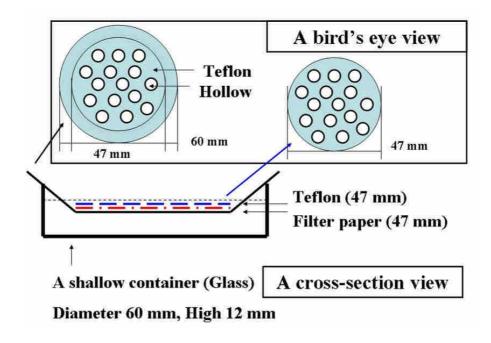




Figure 3-5 A design chart and a photograph of surface sol-gel system.

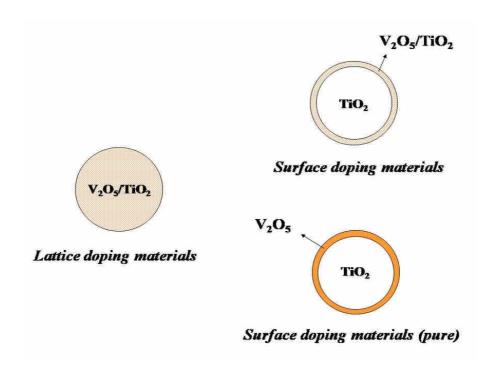


Figure 3-6 The geometric structure of pure, bulk and surface doped TiO₂.

3-4 Characterization

3-4-1 X-ray photoelectron spectroscopy (XPS)

XPS measurements were performed with an ESCA PHI 1600 spectrometer using an Al K α radiation (1486.6 eV). The photoelectrons were collected into the analyzer with a 23.5 eV pass energy. The collection step size in wide range scan and high-resolution analysis are 1.0 eV and 0.1 eV, respectively. All analytical process was controlled under ultrahigh vacuum at the pressure below 1.4×10^{-9} Torr. In addition, bulk chemical compositions were detected after etching by Ar ion for 60 seconds. At low V loading, a charging effect occurs and was corrected using the C 1s peak at 284.8 eV as a reference. For advanced qualification and quantification of each element, curve fitting of XPS spectra was performed on program. The atomic ratio was calculated from the integrated peak areas normalized to sensitive factors. The equation for atomic ratio calculation is shown:

$$\frac{n_1}{n_2} = \frac{I_1}{ASF_1} = \frac{A_1/ASF_1}{A_2/ASF_2} = \frac{A_1/ASF_1}{A_2/ASF_2}$$
(3-1)

Where n denotes the atomic numbers, I is the intensity of species on XPS spectra, A is the peak area, ASF stands for the atomic sensitive factor of element and Arabic number represents

elemental types.

3-4-2 Time-of-Flight Secondary Ion Mass Spectrometer (TOF-SIMS)

SIMS measurements were performed with a TOF-SIMS IV (ION-TOF, Munich, Germany) spectrometer. The TOF-SIMS spectra were recorded at 25 °C in positive detection modes. The primary ion source was a pulsed Ga^+ source (pulsing current 1.0 pA, pulse width 30 ns) operated at 25 keV. An area of $100\times100~\mu\text{m}^2$, a sputter time of 120 s, a data acquisition time of 150 s and charge compensation by applying low energy electrons (~ 30 eV) from a pulsed flood gun were used for all measurements. The pressure of the main chamber was kept around 10^{-9} mbar. The m/z of mass spectra in the positive mode was ranged from 40 to 60.

The surface atomic ratio was calculated from the intensity of secondary ions which are normalized to relative sensitivity factor. A relative sensitivity factor (RSF) is a conversion factor from secondary ion intensity to atom density. The RSF is defined by sub-equation⁶²

$$\rho_{\rm i} = \frac{I_i}{I_m} RSF \tag{3-2}$$

Where ρ_i is the impurity atom density in atoms/cm³, I_i is the impurity isotope (V, m/z=47.9) secondary ion intensity in counts/s, I_m is the matrix isotope (Ti, m/z= 50.8) secondary ion intensity in counts/s, and RSF has unit of atoms/cm³.

3-4-3 Scanning electronic microscopy (SEM)

Scanning electronic microscopy (SEM, Hitachi, S-4700, Type II) was used to observe the morphology of the doped TiO_2 under an accelerating voltage of 25 KV and a pressure of 3×10^{-6} Pa. The samples for the SEM observation were prepared by suspending the powders in 15 mL acetone solution via ultrasonic vibration for 20 minutes. The suspension was then directly dropped on the glass and dried at 100° C. To prevent charge accumulation, the samples were pre-coated with a Au film by Ion coater (Eiko IB-2) for 3 minutes which thickness was 200 Å.

3-4-4 X-ray diffractometry

Powder X-ray diffraction patterns of the samples after calcination were recorded with a computer controlled X-ray powder diffractometer (XRPD, MAC Sience, MXP18) using Cu K α radiation and operating at accelerating voltage of 30 kV and an emission current of 20 mA. The scanning 2 θ range is from 10° to 80° at a sampling width of 0.02° and scanning speed is 4 °/min. If a sample only contains anatase and rutile, the weight ratio of rutile phase (W_R) can be calculated from the following equation:³³

$$W_{\rm R} = \frac{A_{\rm R}}{0.884 A_{\rm A} + A_{\rm R}} \tag{3-3}$$

where A_A is intensity of anatase (101) peak and A_R is intensity of rutile (110) peak. The crystalline size (D) of all samples was calculated from Scherrer's equation:⁶³

$$D = \frac{K \times \lambda}{\beta \times \cos \theta} \tag{3-4}$$

Where d is the crystalline size, λ is the x-ray wavelength (Cu K α = 0.15406 nm), β is the width of the peak (full width at half maximum, FWHM) after correcting for instrumental peak broadening (β expressed in radians), θ is the Bragg angle and K is the Scherrer constant. According to Bragg's law, the d-spacing could be calculated by this law, and geometric figure is shown in Figure 3-11.

$$d = \frac{n\lambda}{2\sin\theta} \tag{3-5}$$

Where d is the d-spacing (nm), λ is the wavelength of incident X-ray, θ is the Bragg angle and n=1.

To investigate the surface structures of the samples, the V_2O_5/TiO_2 films were coated onto glasses and dried at $100^{\circ}C$ for few minutes. The coated film were analyzed by a grazing incident X-ray diffractometer (GI-XRD, Rigaku , RU-H3R), which use Cu K α radiation with incident angle of 1° and operate at accelerating voltage of 60 kV and an

emission current of 300 mA. The scanning 2θ range is from 15° to 80° at a sampling width of 0.02° and scanning speed is $4^{\circ}/\text{min}$.

3-4-5 UV/Vis diffuse reflectance spectroscopy (UV-Vis DRS)

The UV-vis diffused reflectance spectra were recorded on a U-3010 Hitachi spectrometer with an integrating sphere reflectance accessory. The spectra were recorded from 900 to 200 nm at a scanning rate of 300 nm/min. Aluminum oxide, which was considered to exhibit total reflections, was used to be the reference. The spectra were transformed into absorptions according to Kubelka-Munk equation shown in equation 3-6.

$$F(R) = \frac{(1-R)^2}{2R} = \frac{k}{S} \tag{3-6}$$

Where k is absorption coefficient, S is scattering coefficient and R represents %R reflectance

3-4-6 Inductively Coupled Plasma Mass Spectromstry (ICP-MS)

ICP-MS (Perkin Elmer, SCIEX ELAN 5000) was used to analyze bulk chemical compositions for V/Ti weight ratio of all samples. All solid of samples were digested with acid solution coupled with microwave.

3-4-7 Specific surface area

The Brunauer, Emmett, and Teller (BET) surface area of catalysts were measured by N_2 physisorption using a TriStar 3000 gas adsorption analyzer. The BET model was used to estimate the surface area of the samples according to the N_2 adsorption data. For providing sufficient surface area for model calculation, over 0.2 g of powders was used for analysis. Because the calcination temperature of V-doped materials was 300 °C, as-prepared sample was degassed at 120 °C for 6 h.

3-4-8 Electron paramagnetic resonance (EPR)

The photo-induced charge carriers were examined by an electron paramagnetic resonance spectrometer (EPR, Bruker EMX-10/12) working at X-band frequency. A 250 W Hg lamp (Moritex, MUV-250U-L) having a major output wavelength at 365 nm was

positioned at a fixed distance from a sample cavity. In addition, Figure 3-7 shows the distribution of the UV light system (Moritex, MUV-250U-L). The measurements were carried out at 77 K either in the dark or under irradiation. The instrumental conditions were set at a center field of 3400 G and a sweep width of 200.0 G. The microwave frequency was 9.50 GHz and the power was 8.0 mW.

The EPR spin trapping experiments using DMPO were performed at room temperature. The 0.03 M DMPO solution was prepared by adding 0.0345 mL DMPO into 10 mL DI water, and it was stored at 4° C. Each sample was aerated with 30 min O_2 before analysis. After addition of 1 mL of 0.03 M DMPO into 10 mL catalyst suspension (1g/l), the mixtures were shaken by hand to reach a homogeneous condition. Subsequently, the samples were delivered to a quartz capillary tube and analyzed the spin-trapped adducts under irradiation of UV light at room temperature. The settings for the EPR spectrometer were center field = 3480.0 G; sweep width = 200.0 G; microwave frequency 9.77 GHz; modulation frequency 50.0 kHz and power 10 mW. To minimize measurement errors, the same quartz capillary tube was used throughout the EPR measurements.

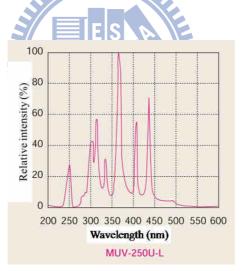


Figure 3-7 The UV lamp spectral distribution. 65

3-4-9 Transmission Electron Microscope (TEM)

The particle size and shape of nanocrystals were examined by a transmission electronic microscopy (TEM, JEM 1200) at an accelerating voltage of 120 KV. The specimen was prepared by dispersing of powders into acetone with ultrasonic vibration. The colloid was dropped on a holey carbon film supported on a Cu grid (Ted Pella, Inc., 200 meshes). TEM images are displayed in Appendix I.

3-5 Photocatalytic of RhB decomposition

Rhodamine B (RhB) was selected as the target compound to test the photocatalytic activity of the doped TiO₂. Figure 3-8 shows the UV-Vis spectrum of 0.01 mM RhB at 400-700 nm. The most intensive absorption peak appeared at 553 nm. The degradation of the RhB was monitored according to the decreasing intensity of this characteristic peak. The catalysts (20.0 mg) were dispersed ultrasonically into 20 mL of RhB solutions at concentration of 0.01 mM in a fused-silica tube. Prior to irradiation, the suspension was purged with O₂ in the dark with stirring for 30 minutes for equilibrium of adsorption and desorption of RhB and saturation of the solution with O₂. The purging was continued during photocatalysis. The photocatalysis was carried out under irradiation of 8 UV lamps each of (8 W) at 365/305 nm. Figure 3-9 displays the cartoon diagram and photographs of the photocatalytic system.

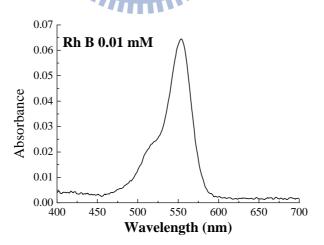


Figure 3-8 The UV-Vis spectrum of 0.01 mM RhB.

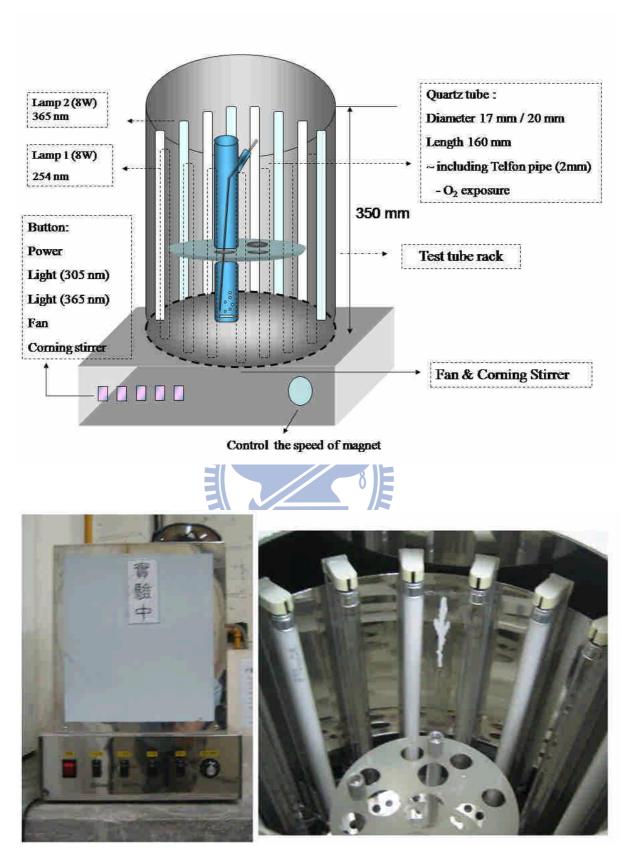


Figure 3-9 A design chart for photocatalysis reactor and A photograph of photocatalytic reactor.

Chapter 4 Results and discussion

4-1 Chemical compositions

To understand the chemical compositions and chemical states of vanadium ions in the bulk lattice and surface sites of the doped TiO_2 , samples were characterized using ICP-MS, SIMS and XPS. Table 4-1 lists the bulk and surface V/Ti atomic ratios of bulk doped materials. Because the vanadium solutions were diluted by 2-isopropanol, the solution creates the errors between added V/Ti ratios and the measured bulk ratios. The bulk V/Ti ratios ranged between 4.41×10^{-5} and 1.22×10^{-2} which were similar to the added ratios (ranged between 5.00×10^{-5} and 1.00×10^{-2}). However, the surface V/Ti ratios ranging 3.03×10^{-5} - 1.67×10^{-2} were slightly larger than the bulk ratios. These results indicate that almost vanadium ions were successfully doped into TiO_2 in the sol-gel process. In addition, higher amounts of the doped vanadium ions were accumulated in the surface lattice.

Table 4-1 The bulk and surface V-to-Ti atomic ratios of bulk doped TiO₂.

Added V/Ti ratios	Bulk V/Ti ratios ^a	Surface V/Ti ratios ^b	Sample name
5.00×10 ⁻⁵	4.41×10 ⁻⁵	7.26×10 ⁻⁵	VT 4.41×10 ⁻⁵
1.00×10 ⁻⁴	1.34×10 ⁻⁴	2.36×10 ⁻⁴	VT 1.34×10 ⁻⁴
5.00×10^{-4}	5.09×10 ⁻⁴	1896 6.72×10 ⁻⁴	$VT 5.09 \times 10^{-4}$
1.00×10 ⁻³	1.27×10 ⁻³	1.84×10 ⁻³	VT 1.27×10 ⁻³
1.00×10 ⁻²	1.22×10^{-2}	1.67×10 ⁻²	VT 1.22×10 ⁻²

^a determined by ICP-MS, ^b determined by SIMS.

Table 4-2 lists the bulk and surface V/Ti atomic ratios for the surface doped materials with increasing contents of vanadium ions. The surface doped TiO_2 contained bulk and surface V/Ti ratios of 1.73×10^{-3} - 1.10×10^{-2} and 1.54×10^{-2} - 2.97×10^{-1} , respectively. Since the surface doped samples were prepared by coating a thin V/TiO₂ film on the TiO_2 particles, the bulk V/Ti ratios were much smaller than the surface ones. Similar to the bulk doped TiO_2 , the surface V/Ti ratios were 1.5 - 2.7 times larger than the added V/Ti ratios of the surface coating $(1.00\times10^{-2}$ - 2.00×10^{-1}), indicating the migration of the vanadium ions from the bulk toward the surface. Davidoson and Che^{58} reported that metal ions migrated to the surface of substance above the Tammann temperature at which the thermal vibrations of cations were strong enough for lattice diffusion. The Tammann temperature is 0.37-0.53 T_f ,

where T_f represents the melting temperature of oxides. The T_f of TiO_2 is 2190 K, thus its Tammann temperature is 780-1118 K.^{16, 58} However, the enhanced mobility of V^{5+} is associated with its lower Tammann temperature of V_2O_5 (i.e. 209 °C) compare to TiO_2 . So, some vanadium ions migrated from bulk lattice toward to surface lattice of TiO_2 .

Herein, the bulk chemical compositions determined by ICP-MS were used to name all the doped samples. For example, the bulk doped TiO_2 with total V/Ti ratio of 4.41×10^{-5} was called VT 4.41×10^{-5} . For surface doped TiO_2 , the sample with total V/Ti of 1.10×10^{-2} was named as SVT 1.10×10^{-2} . In addition, the sample which was coated pure V_2O_5 on TiO_2 was named SVTP. Its total bulk V/Ti ratio was 4.74×10^{-3} , as shown in Appendix F.

Table 4-2 The bulk and surface V-to-Ti atomic ratios of surface doped TiO₂.

Added V/Ti ratios of	Bulk V/Ti ratios ^a	Surface V/Ti ratios ^b	Sample name
the coating layer			
2.00×10 ⁻¹	1.10×10 ⁻²	2.97×10 ⁻¹	SVT 1.10×10 ⁻²
1.00×10 ⁻¹	6.40×10 ⁻³	2.03×10 ⁻¹	SVT 6.40×10 ⁻³
5.00×10 ⁻²	3.47×10 ⁻³	1.37×10 ⁻¹	SVT 3.47×10 ⁻³
1.00×10 ⁻²	1.73×10 ⁻³	1.54×10 ⁻²	SVT 1.73×10 ⁻³

^a determined by ICP-MS, ^b determined by SIMS, 6

The chemical states of the vanadium ions in the bulk and the surface lattices were determined using ESCA (see Appendix D). The vanadium ions at the surface sites were mainly V^{5+} form, while V^{4+} were observed in the bulk lattices. The reduction of V^{5+} to V^{4+} was attributed to thermal-induced dehydroxylation which preliminarily led to the formation of Ti^{3+} sites followed by the consecutive electron transfer from the Ti^{3+} to V^{5+} sites. These processes can be expressed schematically by the following set of reactions.

$${}^{\bullet}OH_{(s)} \to OH_{(s)} + e^{-}_{(s)}$$
 $E^{\circ} = +2.27 \text{ V}$ (4-1)

$$Ti^{4+} + e^{-}_{(s)} \rightarrow Ti^{3+}$$
 $E^{\circ} = -0.52 \text{ V}$ (4-2)

$$Ti^{3+} + V^{5+} \rightarrow V^{4+} + Ti^{4+}$$
 $E^{\circ} = +0.44 \text{ V}$ (4-3)

4-2 Morphology

Figure 4-1 shows the SEM images of as-dried and calcined TiO₂. The surface of the as-dried TiO₂ was smooth. However, the particles were composed of small grains with sizes smaller than 100 nm after calcination at 300 °C. In general, the particles are agglomerated and basically irregular in shape with a substantial variation in particle sizes. The results indicate that degree of agglomeration tended to increase with increasing calcination temperature.⁷⁰ Thus, polycrystalline structure and agglomerated phenomena occurred during calcination at temperature of 300 °C. Figure 4-2 shows the SEM image of the bulk doped TiO₂ calcined at 300 °C. Similar to the pure TiO₂, the bulk doped TiO₂ was also consisted by small grains which was smaller than 100 nm. Figure 4-3 shows the SEM images of surface doped TiO₂ particles and the cross sectional view of its V-doped TiO₂ coating. The surface coating film contained a thickness of around 50 nm. Different from the bulk doped TiO₂, the surface doped TiO₂ was smooth due to rapid hydrolysis while surface sol-gel processes did not add HCl. In addition, the SVTP 4.74×10⁻³ coated a thin film of V₂O₅ on TiO₂ also exhibited smooth morphology (see Appendix F). These findings suggest that the thin film prepared by surface sol-gel was uniform which resulted from lack of HCl.

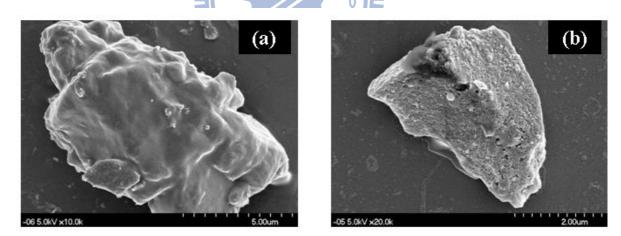


Figure 4-1 The morphology of pure TiO_2 calcined at (a) 150 °C for 3 h and (b) 150 and 300 °C for 3 h.

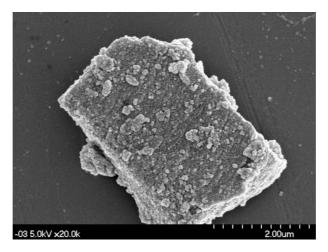


Figure 4-2 The SEM images of bulk doped materials

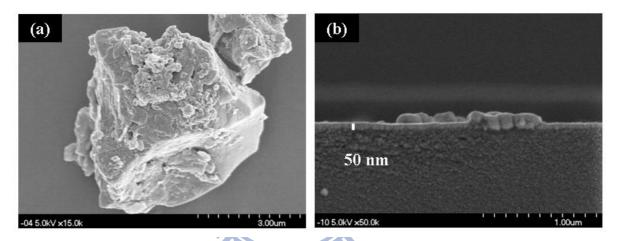


Figure 4-3 The SEM images of (a) surface doped materials and (b) cross sectional view of a V-doped TiO₂ film prepared by the surface sol-gel method.

4-3 Microstructures

To examine the effect of doping sites on the crystalline structure, grain size, d-spacing and specific surface area, all samples were analyzed by XRD and BET. Figure 4-4 displays the crystalline structures of pure and bulk doped TiO₂. The peaks of the anatase (101) and rutile (110) profiles centered at 25.4 and 27.5° 2θ positions, respectively. It indicated the coexistence of anatase and rutile phases in the pure TiO₂ and the weight ratio of rutile was 31.1wt% which error bar is 5 wt%. The weight ratio of rutile (i.e. 21.3-26.5 wt%) of bulk doped materials slightly decreased while V/Ti atomic ratio was lower than 1.27×10⁻³. Besides, the rutile phase was not detected while the V/Ti atomic ratio was higher than 1.27×10^{-3} , indicating that the presence of V^{4+}/V^{5+} inhibits the anatase-to-rutile transformation. The anatase-rutile transformation was restrained by formation of V₂O₅ phase occurred at high vanadium ions and low calcination temperature.⁷¹ No diffraction peaks corresponding to vanadium oxide were observed in the XRD pattern. Therefore, the vanadium ions were either highly dispersed in the TiO₂ matrix or formed as tiny vanadia crystallites having the size beyond the detection capacity of the powder X-ray diffraction technique (less than 5 nm). Table 4-3 lists the d-spacing, crystallite sizes and weight ratios of rutile phases of the bulk doped TiO₂. The d-spacing of (101)_a of the bulk doped TiO₂ were 351 pm. This value was similar to that of pure TiO₂ (350 pm) and the d-spacing was slightly increased from 530 to 353 pm even under heavily doping (See Appendix E). Since the ionic radius of V^{4+}/V^{5+} is 72/68 pm which is closed to that of Ti⁴⁺ (74.5 pm),⁷² the vanadium ions are doped into the TiO₂ lattice by substituting Ti⁴⁺ ions.

The average crystallite sizes of pure TiO_2 , estimated from the broadening of the anatase (101) diffraction peak, are 6.1 nm which error bar is 0.6 nm. Compare with pure TiO_2 , the crystallite sizes (i.e. 6.0-6.5 nm) of bulk doped materials had no obviously difference. The results show the concentration of vanadium-ion (V/Ti < 1.00×10^{-2}) is too low to affect the crystallite size. However, when V/Ti atomic ratio increased to 2.00×10^{-1} , the crystallite size of anatase decreased from 6.1 to 5.2 nm, as shown in Appendix E. The inhibition of the growth of crystallite sizes was resulted from increasing surface energy and surface stress caused by lattice vanadium ions.^{58, 67} Figure 4-5 schematically illustrates the inhibited growth of crystallite sizes of bulk doped TiO_2 .

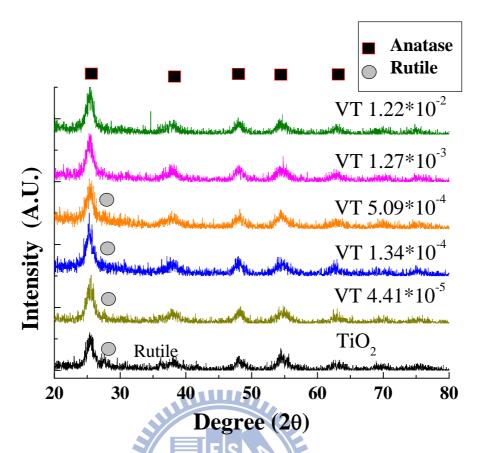


Figure 4-4 The XRD patterns of bulk doped TiO₂ at different vanadium ion concentrations.

Table 4-3 The crystallite sizes, d-spacing of materials and weight ratio of rutile phase of bulk doped TiO_2 .

Bulk doped TiO ₂			
Materials	Crystallite size	d-spacing (pm)	Weight ratio of
	(nm)	(n=1)	Rutile (wt %)
TiO ₂	6.1 ± 0.6	350 ± 0	31.1 ± 5.0
VT 4.41×10 ⁻⁵	6.0	351	21.3
VT 1.34×10 ⁻⁴	6.4	351	24.0
VT 5.09×10 ⁻⁴	6.3	351	26.5
VT 1.27×10 ⁻³	6.5	351	_
VT 1.22×10 ⁻²	6.2	351	_

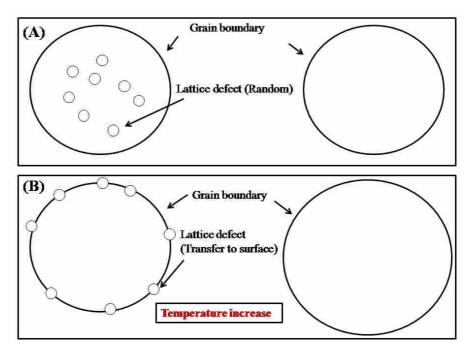


Figure 4-5 The effect of bulk defect on growth of crystal.

To analyze the surface microstructure of the V-doped TiO_2 , GI-XRD was used to examine the surface crystalline properties of the samples. Figure 4-6 shows the GI-XRD patterns of bulk doped TiO_2 . The two peaks centered at 25.4 and 19.2° 20 positions were denoted to anatase and V_2O_5 , respectively. In addition, the relative intensity of V_2O_5 increased with increasing variations. The data indicate parts of variations transferred toward surface of matrix and agglomerated to perform V_2O_5 at 300 °C, while the chemical state of variations was V^{5+} .

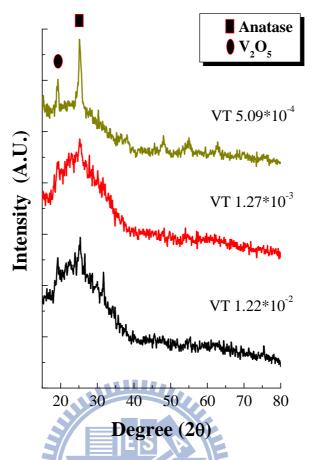


Figure 4-6 The GI-XRD patterns of bulk doping materials.

Figure 4-7 shows the XRD patterns of surface doped TiO_2 . Table 4-4 lists the d-spacing, crystal sizes and weight ratios of rutile phases of the surface doped TiO_2 . The crystallite sizes of anatase TiO_2 were in the range of 6.0-6.5 nm, while their d-spacing of anatase (101) profile were in the range of 350-352 pm. In addition, the weight ratio of rutile were not detected except SVT 1.73×10^{-3} since these characters were similar to those of pure TiO_2 , surface doped V^{5+} ions had little effects on the bulk microstructures of TiO_2 . Figure 4-8 displays the V_2O_5/TiO_2 thin films coated on glass which were prepared by surface sol-gel. In contrast to bulk doped TiO_2 , V_2O_5 crystallites were observed only on the surface of substances. This phenomenon revealed that the TiO_2 was coated with V_2O_5 as a core-shell structure in the surface doped TiO_2 samples. Therefore, the chemical status of vanadium in bulk doped TiO_2 co-existed both V^{4+} and V^{5+} . The chemical status is an important evidence to deduce whether vanadium was located in the TiO_2 octahedral lattice. The V^{4+} was possible in the octahedral lattice of TiO_2 , while V^{5+} may be V_2O_5 highly dispersed within crystalline of TiO_2 . In addition, both the intensity and crystal sizes of V_2O_5 (i.e. 11.2 nm) did not alter with increasing vanadium ions.

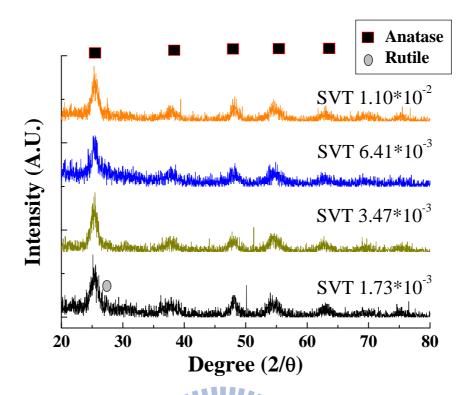


Figure 4-7 The XRD patterns of surface doped materials at different vanadium ions concentration.

Table 4-4 The crystallite sizes of materials and weight ratio of rutile phase of surface doped TiO₂

Surface doped materials			
Materials	Crystal size	d-spacing (pm)	Weight ratio of
	(nm)	(n=1)	Rutile (%)
SVT 1.73×10 ⁻³	6.0	351	25.5
SVT 3.47×10 ⁻³	6.5	352	_
SVT 6.40×10 ⁻³	6.2	350	_
SVT 1.10×10 ⁻²	6.2	350	_

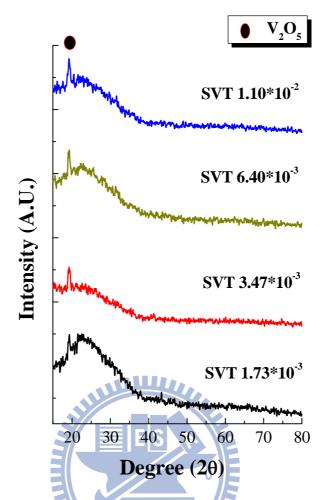


Figure 4-8 The GI-XRD patterns of surface doped materials.

Figure 4-9 illustrates the microstructures of bulk and surface doped TiO_2 . In the bulk doped TiO_2 , vanadium ions were substitutionally doped in the anatase lattice while few V_2O_5 crystals were existed in the surface layers. However, TiO_2/V_2O_5 core-shell structures were formed in the surface doped TiO_2 . The specific surface area of bulk and surface doped TiO_2 were listed in Appendix C. The specific surface areas of bulk doped materials were ranged between 99 and 110 m²/g, while the surface doped materials exhibited their specific surface areas of 99-105 m²/g. Either doping TiO_2 with V^{4+}/V^{5+} ions in the bulk lattice or on the surface sites had little effects on the specific surface areas because the as-dried oxides are usually amorphous, they must be calcined at high temperature for crystallization. Unfortunately, the decreasing crystallite size increased the surface area of the photocatalysts. 70,73

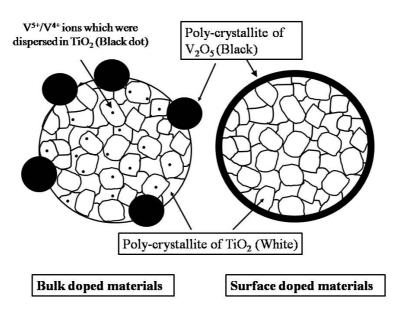


Figure 4-9 The microstructures of bulk and surface doped TiO₂.

4-4 UV-Visible absorption

In order to elucidate the optical properties for photocatalysts, UV-vis diffuse reflectance spectroscopy (DRS) was applied to study the bonding information of the V-doped TiO₂. Figure 4-10 shows the optical absorbance of pure TiO₂ from wavelength of 900 to 200 nm. The absorption edge was at 405 nm, corresponding to 3.1 eV of the bandgap energy. Below 405 nm, there were two bands separated at 263 nm. One broad band was ranged between 200-300 nm and centered at 233 nm which was denoted to upper CB.^{74, 75} The upper band centered at 233 nm was assigned to a charge-transfer transition between the oxygen ligands and a central Ti⁴⁺ ion with a tetrahedral coordination (4-fold).^{74, 75} The other band centered at 353 nm which was denoted to lower CB.

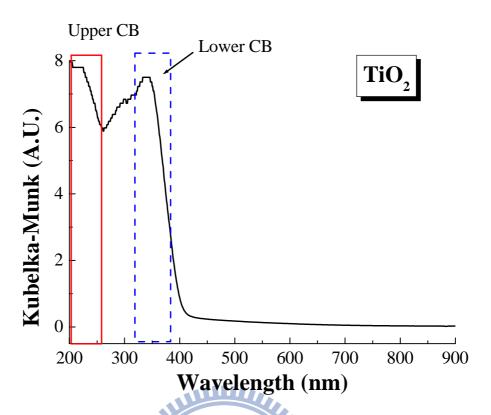


Figure 4-10 UV-Vis DRS spectra of TiO₂. The red solid line: Upper conduction band. The blue dash line: Lower conduction band.

Figure 4-11 shows the optical absorbance of bulk doped TiO_2 with various contents of vanadium-ion doping. The spectra of bulk doped materials showed similar absorption behavior at an absorption edge of around 405 nm (3.1 eV), except VT 1.22×10^{-2} which exhibited the absorption edge of 426 nm (2.9 eV). Table 4-5 lists the band gaps of the bulk doped TiO_2 containing varies V/Ti ratios. The bulk doped TiO_2 with vanadium ions, which was lower 1×10^{-2} , showed a broad adsorption peak ranged 250-320 nm and centered at 289 nm, which was denoted to V^{5+} . The V^{5+} broad band was occurred between upper and lower CB. So, the V^{5+} (3d) bands lied in the CB edge of TiO_2 , and the intensity of V^{5+} peak increased with raising vanadium ions. However, when V/Ti was larger than 1 mol %, the d-d transition of V^{4+} occurred. The results show a broad adsorption from 779 nm in the inside graph of Figure 4-11. So, the V^{5+} ions reduced to V^{4+} under higher vanadium concentration.

Because a spontaneous reduction of V^{5+} to V^{4+} occurred at the vanadium oxide and titanium oxide interface during calcination at temperatures above 450 °C, ^{68, 77} the chemical states of vanadium ions of bulk doped materials was V^{5+} mainly under lower vanadium concentration (V/Ti < 1 mol %) and lower calcination temperature (300 °C < 450 °C). In

addition, the V^{4+} reduced by V^{5+} performed extra band located above VB 1 eV when V/Ti was larger than 1 mol %, as shown in Figure 4-12.^{29,78} In this study, Figure 4-13 shows the different electronic structure with high and low vanadium contents.

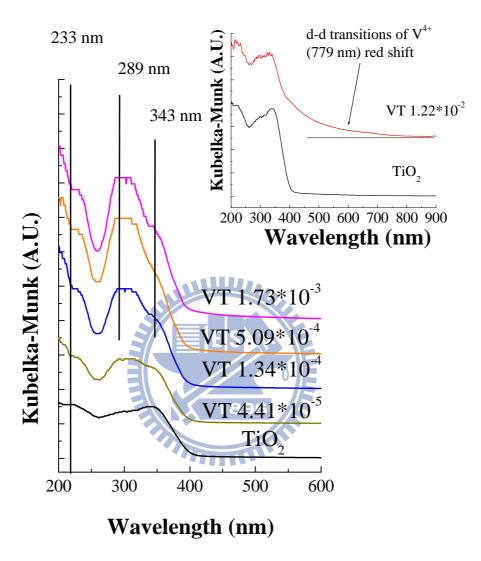


Figure 4-11 The UV-visible absorption spectra of all bulk doped materials at different vanadium ions concentration, except VT 1.22×10^{-2} which is shown in inside graph.

Table 4-5 The band gap energy of bulk doped TiO_2 .

Bulk doped TiO ₂		
Materials	Band gap (eV)	
TiO ₂	3.1	
VT 4.41×10 ⁻⁵	3.1	
VT 1.34×10 ⁻⁴	3.1	
VT 5.09×10 ⁻⁴	3.1	
VT 1.27×10 ⁻³	3.1	
VT 1.22×10 ⁻²	2.9	

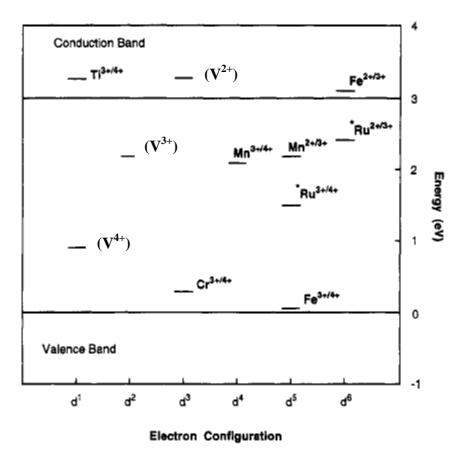


Figure 4-12 Energy levels of impurity ions in rutile.²⁹

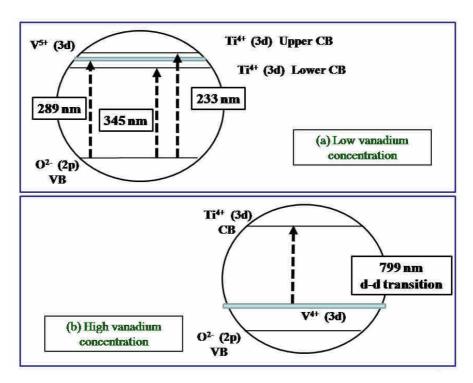


Figure 4-13 The concept of electronic structure for bulk doping materials. (a) low vanadium ions (< 1 mole%); (b) high vanadium ions (i.e. VT 1.22×10^{-2}).

Figure 4-14 displays the optical absorbance of surface doped TiO₂ from wavelength of 900 to 200 nm. The similar absorption behaviors of surface doped materials at an absorption edge of around 405 nm (3.1 eV) are shown in Figure 4-14. Table 4-6 lists the band gap of surface doped TiO₂ at various vanadium ions concentration. The band gap surface doped TiO₂ was around 3.1 eV.

The results show that vanadium ions doped on the surface of TiO_2 had no obvious effect on the electronic structure of TiO_2 . Clearly, the findings indicate that the bulk doping sites had more obvious effect than surface doping site on electronic structure of TiO_2 . Besides, Figure 4-15 illustrates the scheme of electronic structure of TiO_2/V_2O_5 composite semiconductors. It refers that the CB of V_2O_5 was lower than TiO_2 , because d-orbital energy of the highest occupied atomic d-orbital of vanadium was lower than that of titanium.^{79, 80} Therefore, to summarize the salient features of the analysis, the image electronic structure of bulk and surface doped TiO_2 were illustrated in Figure 4-13 and Figure 4-16 respectively.

Table 4-6 The band gap energy of surface doped TiO₂

Surface doped TiO ₂		
Materials	Band gap (eV)	
SVT 1.73×10 ⁻³	3.1	
SVT 3.47×10 ⁻³	3.1	
SVT 6.40×10 ⁻³	3.1	
SVT 1.10×10 ⁻²	3.1	
SVTP 4.74×10 ⁻³	3.1	

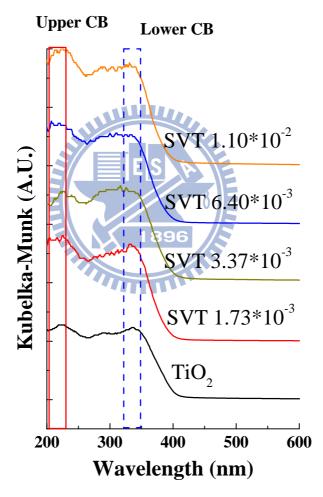


Figure 4-14 The UV-visible absorption spectra of the surface doped materials at different vanadium ions concentrations.

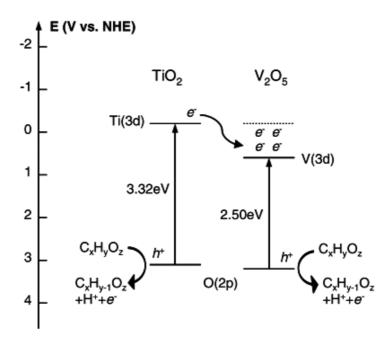


Figure 4-15 $\,$ Schematic band energy diagram for the TiO_2/V_2O_5 composite semiconductor. 80

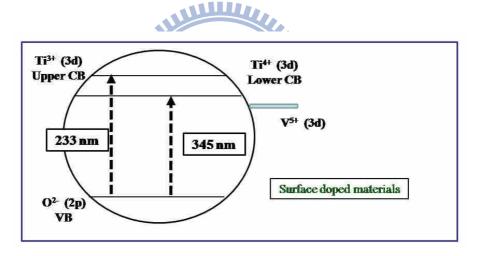


Figure 4-16 The electronic structure of surface doping materials.

4-5 Photocatalytic activity

The photocatalytic activities of vanadium ions doped TiO₂ was examined by the decoloration of 0.01 mM RhB monitored at 553 nm. Figure 4-17 displays the photocatalytic activities of bulk doped TiO₂ irradiated with UV light at 365 and 305 nm, respectively. In the absence of a photocatalyst, RhB was stable when irradiated with UV light at 365 and 305 The photodecomposition of RhB followed pseudo-first-order kinetics with 305 nm The degradation of RhB in the presence of the prepared nanocrystals indicated irradiation. each of the bulk doped photocatalysts exhibited lower photoactivity. Since all bulk doped TiO₂ exhibit anatase form and similar band gaps (3.1-2.9 eV); it is suggested that the extra energy band caused by vanadium ions had negative influence on the photoactivities, because V⁴⁺ reduced by V⁵⁺ acted as recombination center, as shown in Figure 4-18. Moreover, the decreased photocatalytic activities were caused by increasing vanadium-ion doping. In addition, the tendency of photodecomposition of RhB with 365 nm irradiation was similar to 305 nm irradiation. Figure 4-18 displays the dependence of photocatalytic rate constants of bulk doped TiO₂ on the V/Ti ratios under irradiation of UV light at 365 and 305 nm. According to Langmuir-Hinshelwood (LH) kinetics, the photodecomposition of RhB was followed zero-order kinetics under 365 nm UV irradiation and that was followed pseudo-order kinetics with 305 nm irradiation. The difference was presumably due to fewer amounts of charge carriers were generated under irradiation of the UV light with higher Thus, the effective concentration of RhB was augmented and zero-order wavelength. kinetics was followed under this situation.

Table 4-7 lists the degradation rate constant (min⁻¹) of bulk doped samples with UV light at 365 and 305 nm. The VT 4.41×10^{-5} (k = 5.60×10^{-2} min⁻¹) exhibited the highest rate of decomposition of RhB with UV at 305 nm, followed by, TiO₂ (k = 5.20×10^{-2} min⁻¹), VT 1.34×10^{-4} (k = 5.10×10^{-2} min⁻¹), VT 5.09×10^{-4} (k = 4.00×10^{-2} min⁻¹), VT 1.27×10^{-3} (k = 3.30×10^{-2} min⁻¹) and VT 1.22×10^{-2} (k = 1.50×10^{-2} min⁻¹). Under 365 UV irradiation, the samples with bulk doped ratios lower than 5.09×10^{-4} exhibited similar rate constants (k = 1.33×10^{-2} mM/min) for decomposition of RhB followed by VT 1.27×10^{-3} (k = 1.00×10^{-2} mM/min) and VT 1.22×10^{-2} (k = 6.00×10^{-3} mM/min).

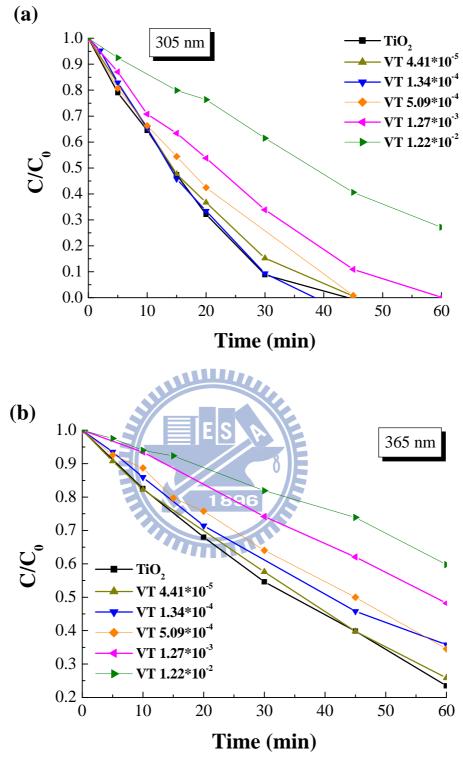


Figure 4-17 The decoloration of 0.01 mM RhB by pure and bulk doped TiO₂ under (a) 305 nm and (b) 365 nm UV irradiation.

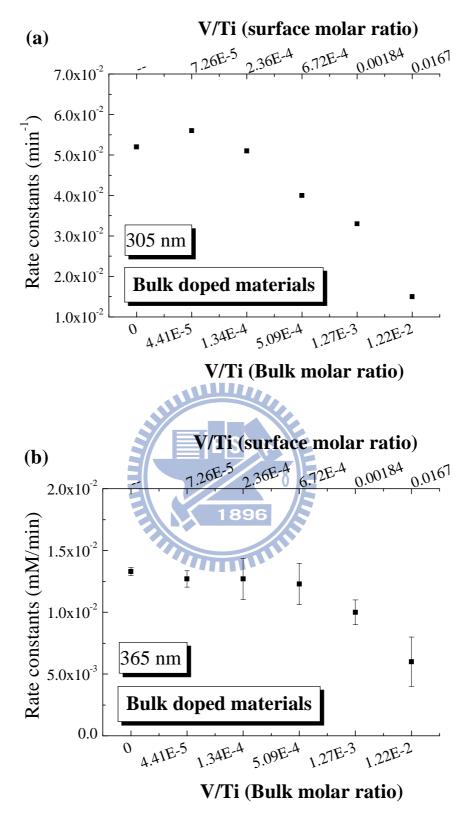


Figure 4-18 The rate constants of bulk doped materials at various vanadium ions concentration compared with pure TiO₂ under (a) 305 nm UV and (b) 365 nm UV irradiation.

Table 4-7 The rate constants of bulk doped TiO_2 at various vanadium concentration compared with pure TiO_2 under 365 and 305 nm UV irradiation.

Bulk doped TiO ₂					
Sample name	Surface V/Ti	Rate constants at 365 nm	Rate constants at 365 nm		
	ratio ^a	UV irradiation (mM/min)	UV irradiation (min ⁻¹)		
TiO ₂	_b	$1.33 \times 10^{-2} \pm 3.33 \times 10^{-4}$	5.20×10 ⁻²		
VT 4.41×10 ⁻⁵	7.26×10 ⁻⁵	$1.27 \times 10^{-2} \pm 6.67 \times 10^{-4}$	5.60×10 ⁻²		
VT 1.34×10 ⁻⁴	2.36×10 ⁻⁴	$1.27 \times 10^{-2} \pm 1.67 \times 10^{-3}$	5.10×10 ⁻²		
VT 5.09×10 ⁻⁴	6.72×10 ⁻⁴	$1.23\times10^{-2}\pm1.67\times10^{-3}$	4.00×10 ⁻²		
VT 1.27×10 ⁻³	1.84×10 ⁻³	$1.00 \times 10^{-2} \pm 2.00 \times 10^{-3}$	3.30×10 ⁻²		
VT 1.22×10 ⁻²	1.67×10 ⁻²	$6.00 \times 10^{-3} \pm 2.00 \times 10^{-3}$	1.50×10 ⁻²		

^a determined by SIMS. ^b not available.

For pure TiO_2 with 305 nm irradiation, the rate constant was 5.20×10^{-2} min⁻¹. When the V/Ti ratio increased to 1.34×10^{-4} , the photoactivity increased to 6.10×10^{-2} min⁻¹ which was similar to pure TiO_2 . The photo-electrons were trapped in bulk-V⁵⁺ sites which position was lower than upper CB after 305 nm UV irradiation while the lots of generated holes performed at the same time. Unfortunately, it was hard to confirm the photo-holes migrated to surface and reacted with donors without recombined with electrons. Moreover, the photocatalytic activities of bulk doped materials with low vanadium-ion doping were similar to pure TiO_2 . Nevertheless, when the bulk V/Ti higher than 1.00 atomic percent, the photoactivity decreased from 6.10×10^{-2} to 1.50×10^{-2} min⁻¹. Because parts of generated holes were trapped by V⁴⁺ ions reduced from V⁵⁺, the trapped holes could not react with donors. Moreover, the substitution V⁴⁺ in the lattice of quantum-size TiO_2 acted primarily as a charge-carrier recombination center that with a net reduction: $V^{3+} + V^{5+} \rightarrow 2$ V⁴⁺ when the electrons/holes were hard to migrate to surface and react with acceptors/donors, as shown in Figure 4-19.¹⁴

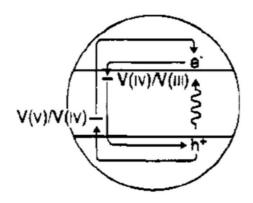


Figure 4-19 The concept of higher content V⁴⁺ at substitutional site in Q-size TiO₂ lattice.¹⁴

Figure 4-20 displays photocatalytic activity of surface doped TiO₂ irradiated with UV light at 365 and 305 nm. The photodecomposition of RhB was followed pseudo-first-order kinetics with 305 nm irradiation and it was followed zero-order kinetics with 365 nm irradiation. The tendency of photoactivities with 305 nm was similar to 365 nm irradiation. Therefore, the mechanism of photocatalysis at 305 nm irradiation was discussed since all surface doped TiO₂ exhibited anatase form and similar band gaps (3.1 eV); it suggested that the surface structural properties had a greater influence on the photoactivities rather than the bulk ones do.

Figure 4-21 displays the dependence of photocatalytic rate constants of surface doped TiO₂ on the V/Ti ratios under irradiation of UV light at 365 and 305 nm. Table 4-8 lists the dependence of photocatalytic rate constants of the surface doped TiO₂ irradiated with 305 and 365 nm UV light on the various V/Ti ratios. And the SVT 1.10×10^{-2} sample (k = 9.80×10^{-2} min⁻¹) exhibited the highest rate of decomposition of RhB with 305 nm irradiation, followed by SVT 6.40×10^{-3} (k = 6.30×10^{-2} min⁻¹), SVT 3.47×10^{-3} (k = 5.90×10^{-2} min⁻¹), TiO₂ (k = 5.20×10^{-2} min⁻¹), SVT 5.09×10^{-4} (k = 4.60×10^{-2} min⁻¹). Under 365 UV irradiation, the SVT 1.10×10^{-2} sample (k = 1.80×10^{-2} mM/min) exhibited the highest rate of decomposition of RhB, followed by SVT 6.40×10^{-3} (k = 1.40×10^{-2} mM/min), TiO₂ (k = 1.33×10^{-2} mM/min), SVT 3.47×10^{-3} (k = 1.25×10^{-2} mM/min), SVT 5.09×10^{-4} (k = 1.07×10^{-2} mM/min).

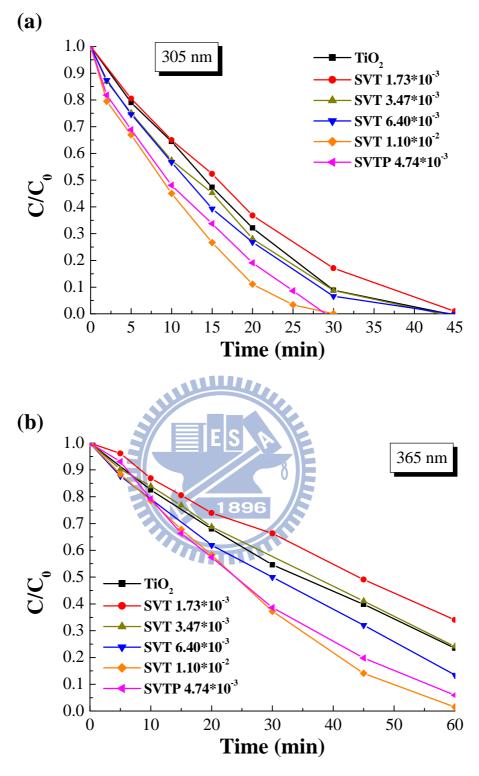


Figure 4-20 The decoloration of 0.01 mM RhB by surface doping materials at various vanadium ions concentration compared with pure TiO₂ under (a) 305 nm UV and (b) 365 nm UV irradiation.

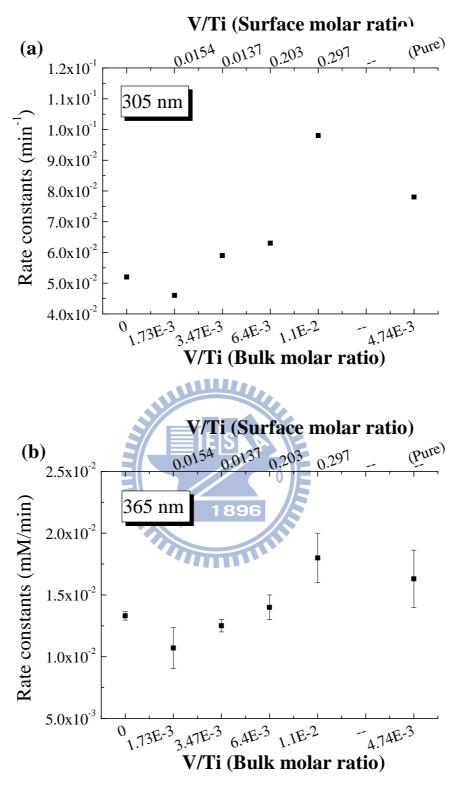


Figure 4-21 The rate constants of surface doped materials at various vanadium ions concentration compared with pure TiO₂ under (a) 305 nm UV and (b) 365 nm UV irradiation.

Table 4-8 The rate constants of the surface doped TiO₂ at various V/Ti ratios.

		Surface doped TiO ₂	
Sample name	Surface V/Ti ^a	Rate constants at 365 nm	Rate constants at 305 nm
		UV irradiation (mM/min)	UV irradiation (mM/min)
SVT 1.73×10 ⁻³	2.97×10^{-1}	$1.07 \times 10^{-2} \pm 1.67 \times 10^{-3}$	4.60×10^{-2}
SVT 3.47×10 ⁻³	2.03×10 ⁻¹	$1.25 \times 10^{-2} \pm 5.00 \times 10^{-4}$	5.90×10 ⁻²
SVT 6.40×10 ⁻³	1.37×10 ⁻¹	$1.40 \times 10^{-2} \pm 1.00 \times 10^{-3}$	6.30×10 ⁻²
SVT 1.10×10 ⁻²	1.54×10 ⁻²	$1.80 \times 10^{-2} \pm 2.00 \times 10^{-3}$	9.80×10 ⁻²

^a determined by SIMS.

For pure TiO_2 , the rate constant was $6.30\times10^{-2}~\text{min}^{-1}$. When the V/Ti ratio increased to 1.73×10^{-3} , the photoactivity of surface doped materials decreased to $4.60\times10^{-2}~\text{min}^{-1}$. The low photocatalytic activity was attributed to improved charge recombination at surface defect sites. When the V/Ti atomic ratios ranged between 3.47×10^{-3} - 6.40×10^{-3} , the rate constants were similar to pure TiO_2 . In contrast to the pure and V-doped TiO_2 , the photocatalytic activities of SVT 1.10×10^{-2} showed the highest photoactivity (i.e. $9.80\times10^{-2}~\text{min}^{-1}$), which was 2 times higher than that of pure TiO_2 . The existence of V_2O_5 shell on the surface promoted charge diffusion to its conduction band and then effectively conducted the charge carriers to adsorbed reactants to enhance the photocatalytic activity at high V/Ti ratios.

4-6 EPR studies of bulk and surface doping materials

EPR technique was used to gain the information about the nature of vanadium species in the V-doped TiO_2 and to understand their photocatalytic mechanism. All the data were acquired with UV irradiation or in the dark at 77K. Figure 4-22 illustrates the EPR spectra of the pure TiO_2 before and after UV irradiation at 77K. There was no observable peak appear in the dark. However, after irradiation with UV light, one of additional signals at $g_1 = 2.011$, $g_2 = 2.007$, and $g_3 = 2.002$ was detected, denoting trapped holes at surface O sites. The other one at g = 2.06 was detected, denoting superoxide radical anion $(O_2^{-1})^{.81,82}$. However, the Ti^{3+} and •OH did not appear in Figure 4-22 after UV irradiation. Because Ti^{3+} ions were easily oxidization to Ti^{4+} and the electron transferred to O_2 which was adsorption on the surface of TiO_2 , oxygen was chemically adsorbed by O_2^{2-} ion at room to low temperature process. Besides, O_2^{2-} simultaneously had hole-reduction agent and electron consumed

agent function, and O_2^- was the product by hole/electron consumed reaction. That is why O_2^- signal can be detected in EPR system after UV irradiation with low vanadium concentration.⁸³ In addition, after UV irradiation, a little parts of photo electrons transferred to surface and reacted with oxygen to perform superoxide radical anion $(O_2^{\bullet-})$ while holes were trapped by oxygen vacancy. Therefore, the superoxide radical anions and trapped holes were detected in EPR spectra, as shown in Figure 4-22.

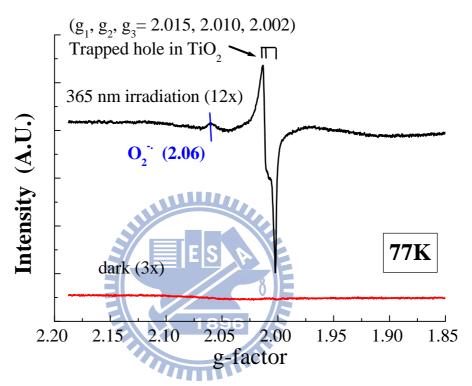


Figure 4-22 The difference in EPR spectra of pure TiO₂ before and after irradiation of UV at 77K.

Figure 4-23 displays the EPR spectra of the bulk doped TiO_2 at various vanadium concentrations in the dark at 77K. The observable peaks denoted vanadium ions were found in the dark at 77K. The hyperfine structure of V^{4+} ions of bulk doped materials were resulted from the interaction between the unpaired $3d^1$ electron and the vanadium nucleus spin (I = 7/2). Thus, Figure 4-24 shows eight lines, leading to the following EPR parameters: $g_{\perp} = 1.985.^{84}$. The results indicate that a portion of V^{5+} ions, which can not be detected by EPR, were reduced to V^{4+} . The remaining V^{4+} diffused into the anatase lattice as substitutional V^{4+} . Figure 4-25 shows the EPR spectra of the bulk doped TiO_2 at various vanadium concentrations under UV irradiation at 77K. Compared with pure TiO_2 , the trapped holes increased while V/Ti ratios increased from 0 to 1.34×10^{-4} . The intensity of trapped holes

showed a downturn when V/Ti increased from 5.09×10^{-4} to 1.27×10^{-3} . However, when the bulk V/Ti ratio was higher than 1.22×10^{-2} , only V⁴⁺ ions were observed in the EPR spectra.

Figure 4-25 shows three types of phenomena, denoting to low, intermediate and high vanadium concentration. For low vanadium concentration, two additional peaks occurred after UV irradiation, denoting to superoxide radical anions and trapped holes. It seemed that parts of photo electrons were trapped by V⁵⁺ ions spread in the lattice of TiO₂ while photo holes increased simultaneously. In addition, some excited electrons transferred to surface and reacted with oxygen to perform superoxide radical anion (O₂··). The residual excited electrons remained in conduction band of TiO₂ or were trapped by Ti⁴⁺ ions, which were not detected by EPR. Therefore, compared with TiO₂, the trapped holes of surface doped TiO₂ increased when some photo electrons were trapped by bulk-V⁵⁺. At intermediate vanadium concentration, three additional peaks, including superoxide radical anions, trapped holes and V⁴⁺ ions were observed in Figure 4-25 after UV irradiation. It referred the parts of excited electrons were migrated to surface and reacted with oxygen to perform superoxide radical anions (O₂··) or were trapped by V⁵⁺ ions. However, the other parts of photo holes were trapped by V⁴⁺ ions which were dispersion in the lattice of TiO₂. So, the intensity of trapped holes declined while V/Ti atomic ratio increased from 0.01 % to 0.1 %.

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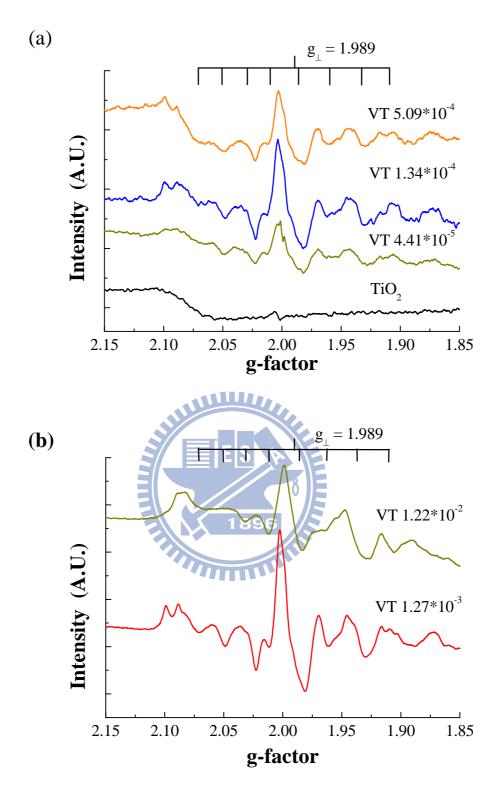


Figure 4-23 EPR spectra of pure and bulk doped TiO_2 at different vanadium contents at 77K in the dark. (a) The bulk V/Ti ratios ranged 0-5.09×10⁻⁴ and (b) The bulk V/Ti ratios in the range 1.27×10^{-3} - 1.22×10^{-2} .

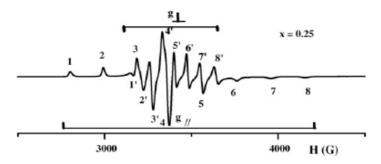


Figure 4-24 The EPR spectra of vanadium ions doped in TiO_2 .⁸⁴

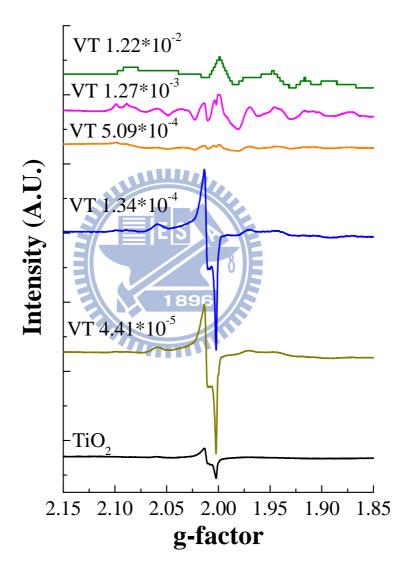


Figure 4-25 EPR spectra of bulk doped materials at various vanadium concentrations under UV irradiation at 77K.

With high vanadium concentration, only eight peaks denoted V^{4+} ($g \perp = 1.989$) were found before and after UV irradiation. It indicated the photo-electrons and photo-holes were both trapped by V^{4+} , besides the trapped electrons recombined with trapped holes easily.

Moreover, even V_2O_5 crystalline structure formed on the surface of VT 1.22×10^{-2} , its photocatalytic activity was 2.5 times lower than that of pure TiO_2 since only few excited electrons/holes transferred to surface and reacted with accepters/donors. Therefore, bulk- V^{4+} ions dispersion in the lattice of TiO_2 had negative effect on charge diffusions.

To summary the photocatalytic mechanism bulk doped materials; the phenomena separated three parts are shown in Figure 4-26 to Figure 4-28, such as low vanadium concentration, intermediate vanadium concentration and high vanadium concentration. In the three figures, the red square meant the species can be detected by EPR and the other ones meant can not be detected by EPR.

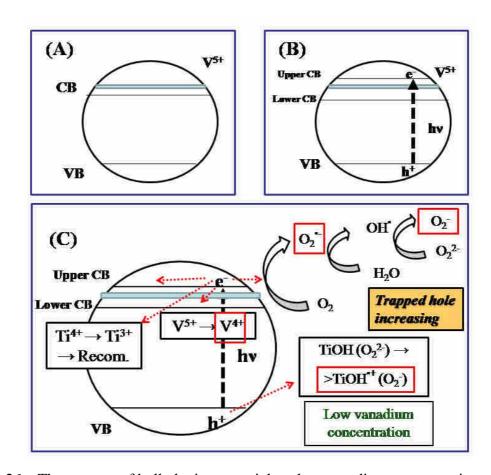


Figure 4-26 The concept of bulk doping materials at low vanadium concentration.

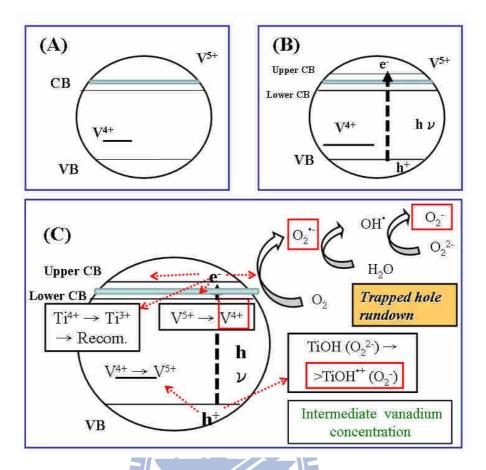


Figure 4-27 The concept of bulk doping materials at intermediate vanadium concentration.

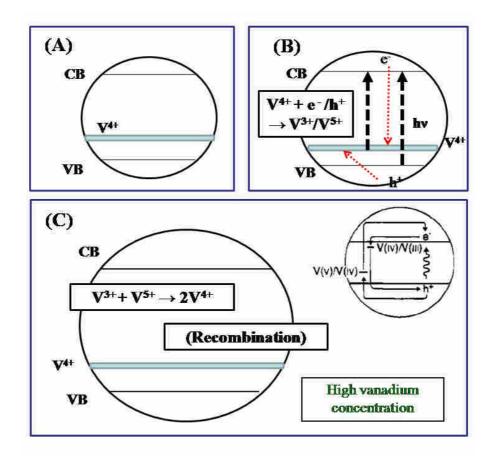


Figure 4-28 The concept of bulk doping materials at high vanadium concentration.¹⁴

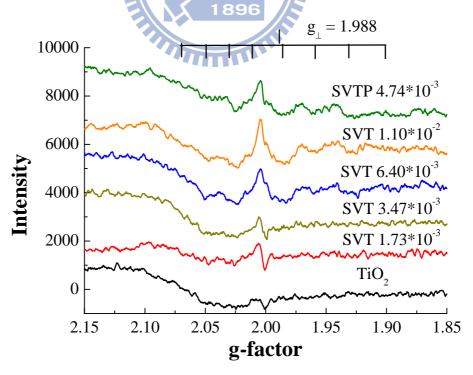


Figure 4-29 EPR spectra of surface doping materials at various vanadium concentration in the dark at 77K.

Figure 4-29 shows EPR spectra of surface doped TiO_2 at various vanadium concentration in the dark at 77K. The V^{4+} signals except SVT 1.73×10^{-3} and SVT 3.47×10^{-3} were detected, because the concentration of the V^{4+} ions were too low to be detected by EPR. Figure 4-30 displays EPR spectra of surface doped TiO_2 at various vanadium concentrations under UV irradiation at 77K. The addition of three peaks, including superoxide radical anions, trapped holes and V^{4+} ions were observed after UV irradiation. The appearance of V^{4+} indicated trapping photo-generated electrons by surface V^{5+} ions. Because the surface- V^{5+} has higher ionic charge and smaller ionic radius than Ti^{4+} , the electrons migrated to surface is more readily. ¹⁹ In addition, the photocatalytic mechanism of surface doped TiO_2 is shown in Figure 4-31. The photo electrons were trapped by surface- V^{5+} while trapped holes/electrons were easily migrated to surface and reacted with donors/acceptors. Thus, the photocatalytic activity of surface doped TiO_2 increased with the increasing vanadium-ion contents. Besides, Table 4-9 lists the g-factor of EPR for easy reference. The EPR data are separated four parts, i.e. as trapped holes, trapped electrons, vanadium ions and radicals.

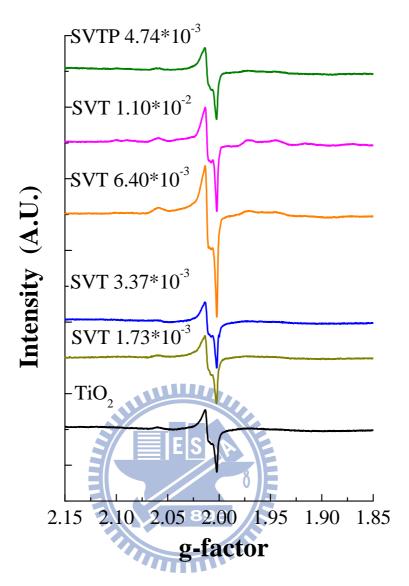


Figure 4-30 EPR spectra of surface doped materials at various vanadium concentrations under UV light at 77K.

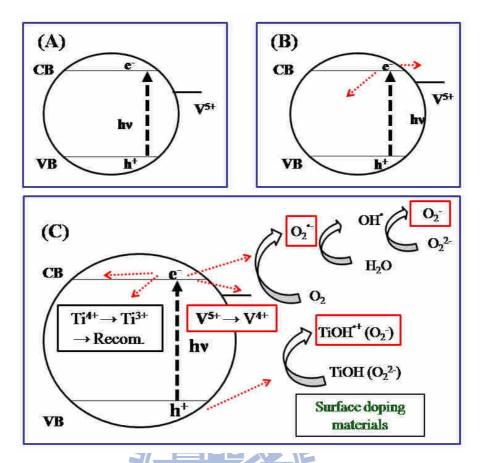


Figure 4-31 The concept of surface doped materials.

Table 4-9 g value for various paramagnetic species.

g factor	assignment	Ref.
g1 =1.961; g2= 1.992; g3 = 1.992	Inner Ti ³⁺ (interstitial, colloidal TiO ₂)	13, 85
g1 =1.960; g2= 1.990; g3 = 1.990	Electron trapping sites (anatase)	86
$g_{\perp} = 1.990$; $g_{\parallel} = 1.957$	Lattice electron trapping sites (anatase)	37
$g_{\perp} = 1.975$; $g_{\parallel} = 1.940$	Lattice electron trapping sites (rutile)	37
g1 =2.002; g2= 2.011; g3 = 2.018	Ti ⁴⁺ O ⁻ Ti ⁴⁺ OH ⁻ (hydrated anatase)	13, 85
g1 =2.004; g2= 2.018; g3 = 2.030	Ti ⁴⁺ O ²⁻ Ti ⁴⁺ O ⁻ (surface, colloidal TiO ₂)	13, 85
g1 =2.002; g2= 2.012; g3 = 2.016	Trapped hole in TiO ₂	86, 87
g1 =2.007; g2= 2.014; g3 = 2.024	Trapped hole in TiO ₂	14
g3 = 2.06	O ₂ · (on TiO ₂ , adsorbed oxygen)	13, 85
g1 =2.001; g2= 2.009; g3 = 2.021	O_2 (on anatase)	14
g1 =2.003; g2= 2.009; g3 = 2.025	O ₂ (on anatase)	86
$g_{\perp}=1.913$; $g_{\parallel}=1.980$	V ⁴⁺ (amorphous V ₂ O ₅)	58
$g_{\perp} = 1.932$; $g_{\parallel} = 1.975$	V ⁴⁺ (hydrated V ₂ O ₅)	58
$g_{\perp} = 1.923$; $g_{\parallel} = 1.986$	V ⁴⁺ (crystalline V ₂ O ₅)	58
$g_z=1.911$; $g_x=1.983$	$V^{4+}(in\ V_2O_5)$	14
g1 = 1.912; g2= 1.914; g3 = 1.956	V ⁴⁺ (in TiO ₂) surface	57
g1 = 1.913; g2= 1.915; g3 = 1.956	V ⁴⁺ (in TiO ₂) _{surface}	58
g1 = 1.912; g2= 1.914; g3 = 1.956	V ⁴⁺ (in rutile) _{surface}	57
$g_{\perp} = 1.960$; $g_{\parallel} = 1.932$	V^{4+} (in anatase) $_{surface}$	57, 88
$g_z = 1.940$; $g_x = 1.986$; $g_y = 1.993$	V ⁴⁺ (in rutile) _{bulk}	14, 58

DMPO spin trapping EPR experiments have been carried out to detect free radical intermediates generated during the irradiation process and to provide essential information on understanding the reaction mechanism. In order to understand the ability of interfacial charge transfer of the bulk and surface doped materials, the generation of •OH were detected via EPR. Figure 4-32 shows the EPR spectrum of DMPO (3.00×10⁻² M) to O₂-saturated aqueous solutions, followed by in situ light irradiation of UV light. Its EPR parameters are characteristic of •OH-DMPO adducts formed upon trapping of OH radicals by the DMPO

molecules. Figure 4-32 shows the signals identified the characteristic •OH-DMPO occurred since the UV light can decompose water to perform •OH.

Table 4-10 summarizes •OH generated in the bulk doped TiO_2 suspensions irradiated with UV light. The integrated area of •OH signals increased from 3.24×10^7 to 8.18×10^7 when the bulk V/Ti ratios increased from 0 to 1.22×10^{-2} . The •OH-DMPO adduct decayed because two •OH, which performed on the surface of materials, recombined together while its can not detected by EPR, as shown in Figure 4-33.⁸⁹ Moreover, the decreasing integrated area were caused by recombination of two •OH since too many •OH produced by reaction between generated electrons/holes and oxygen/water. For examples, the generated •OH on the surface declined due to the photo electrons/holes were both trapped by V^{4+} ions, which was doped in the bulk lattice of VT 1.22×10^{-2} . Moreover, the integrated area of •OH was higher than pure TiO_2 .

Table 4-11 lists integrated area of •OH of surface doped TiO₂. The integrated area of •OH signals decreased from 6.57×10⁷ to 4.42×10⁷ when the bulk V/Ti ratios increased from 0 to 1.10×10⁻². The generation of •OH increased with increasing vanadium ions, because the excited electrons were trapped by surface V⁵⁺ which migrated to surface easily, especially SVT 1.10×10⁻². Thus, relative to photoactivity of V-doped TiO₂, substantial recombination centers at V⁴⁺ sites lead to detrimental effects on the low photocatalytic activity of bulk doped samples. However, surface-V⁵⁺ promotes electrons diffusion to surface and further facilities charges transfer to reactants, thereby greatly improving the degradation efficiency.

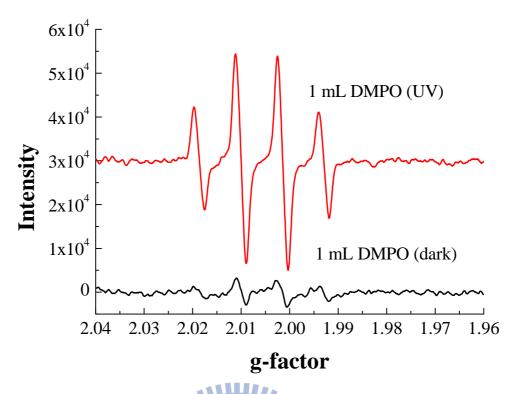


Figure 4-32 The ERP spectrum of •OH-DMPO in the dark and UV irradiation.

Table 4-10 The integrated areas of \bullet OH-DMPO signals obtained from the bulk doped TiO₂ suspension under UV irradiation. The suspensions were aerated with O₂ for 30 min in the dark before irradiation.

	Bulk doped'	ΓiO ₂	
Sample name	Integrated area	Calibrated values ^a	Photoactivity
1 mL DMPO	8.64×10^{7}	<u>_</u> b	_ <i>b</i>
TiO ₂	3.24×10^7	5.40×10^7	
VT 4.41×10 ⁻⁵	4.92×10 ⁷	3.72×10^{7}	
VT 1.34×10 ⁻⁴	5.43×10 ⁷	3.21×10^{7}	
VT 5.09×10 ⁻⁴	5.93×10 ⁷	2.71×10^{7}	
VT 1.27×10 ⁻³	6.34×10 ⁷	2.30×10^{7}	Increase
VT 1.22×10 ⁻²	8.19×10 ⁷	5.50×10^6	

^acalibrated values= integrated area of DMPO – integrated area of samples. ^b not available.

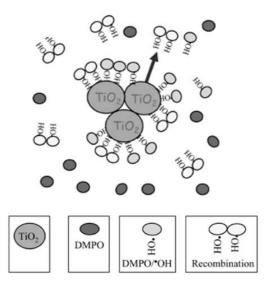


Figure 4-33 The mechanisum of •OH-DMPO adducts formed upon trapping of OH radicals by the DMPO molecules.⁸⁹

Table 4-11 The integrated areas of •OH-DMPO signals obtained from the surface doped TiO_2 suspension under UV irradiation. The suspensions were aerated with O_2 for 30 min in the dark before irradiation.

	Surface doped T	$ m iO_2$	
Sample name	Integrated area 396	Calibrated values ^a	Photoactivity
${ m TiO_2}$	6.57×10 ⁷	2.07×10^7	
SVT 1.73×10 ⁻³	5.94×10^7	2.70×10^7	_
SVT 3.47×10 ⁻³	6.25×10 ⁷	2.39×10^{7}	_
SVT 6.40×10 ⁻³	5.77×10 ⁷	2.77×10^{7}	_ Increase
SVT 1.10×10 ⁻²	4.42×10^{7}	4.22×10^{7}	

^acalibrated values= integrated area of DMPO – integrated area of samples.

Chapter 5 Conclusions

In this study, the influence of bulk and surface doping sites on chemical compositions, photoactivity, electronic- and micro- structure of V-doped TiO₂ were discussed. V₂O₅ was formed on the surface because the low Tammann temperature induced the diffusion of vanadium ions from bulk lattice toward surface lattice. In addition, some incorporated V⁵⁺ ions were reduced to V⁴⁺ ions when the bulk V/Ti ratios higher than 1 mol%. The lattice V^{5+}/V^{4+} not only decreased the anatase-rutile transformation at 300 °C but also inhibited growth of crystal size of anatase TiO₂ at high vanadium concentration. In bulk doped TiO₂, lattice-V⁵⁺ ions trapped electrons thus increased the number of trapped holes. However, the trapped holes decreased when V/Ti ratios were higher than 1 mol% because lattice- V^{4+} ions acted as recombination centers. Prompt charge recombination led to the decrease in photoactivities of bulk doped TiO₂ with increasing contents of vanadium ions. In contrast to bulk doped TiO2, V2O5 shell was coated on the surface of TiO2 when vanadium ions were doped in the surface lattice of TiO₂. The surface-V⁵⁺ ions had no obvious effect on the micro- and electronic- structure of TiO2. However, they promoted electrons diffusion to surface and further facilities charges transfer to reactants because the d-orbital energy of V5+ was lower than that of conduction band of titanium. Therefore, the surface defects contributed to high photoactivity, while bulk ones had detrimental effects on photodegradation of RhB under irradiation of UV light.

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Appendix A Experimental parameters

Appendix A-1 Operational parameter of XPS.

Mode	Binding	Pass energy	Anode	Step size	Time/steps
	energy				
Survey	1200-0 eV	23.5 eV	Al	1.0 eV	50 ms
Multiplex	Depending	23.5 eV	Al	0.1 eV	50 ms
	on element				

Appendix A-2 Detail operational of XPS in multiplex.

Element	Pass Energy	Step size	Scan times	BE range	ASF
O 1s	23.5 eV	0.1 eV	20	529.3-531.2	0.711
Ti 2p	23.5 eV	0.1 eV	20	458.2	2.001
V 2p	23.5 eV	0.1 eV	80	517.6	2.116

Appendix A-3 Relative sensitivity factor of SIMS.

Sample name	Impurity	Matrix 6	Impurity	Relative sensitivity
V (Impurity)	density,	secondary ions	secondary ions	factor (RSF)
Ti (Matrix)	ρ_i (atoms/cm ²)	intensity, I_i	intensity, I_m	
VT 7×10 ⁻¹	1.74E+18	93785	107849	1.51×10 ¹⁸
VT 1×10 ⁻⁴	2.49E+14	276246	93	7.40×10 ¹⁷

Appendix A-4 Raw data of SIMS.

Sample name	Vanadium	Impurity (V) Titanium		Matrix (Ti)	Impurity
	(m/z)	secondary ions	(m/z)	secondary ions	density,
		intensity, I_m		intensity, I_i	ρ_i (atoms/cm ²)
VT 4.4E-5	50.68	41	47.97	399106	1.55×10^{14}
VT 1.3E-4	50.83	305	47.97	320761	1.44×10^{15}
VT 5.1E-4	50.86	368	47.93	587123	9.48×10^{14}
VT 1.3E-3	50.99	1979	47.94	759273	3.94×10^{15}
VT 1.2E-2	50.90	16152	47.93	683923	3.57×10^{16}
SVT 1.7E-3	50.96	9009	47.97	414003	$3.29E\times10^{16}$
SVT 3.5E-3	51.04	1616	47.87	8317	$2.94E\times10^{17}$
SVT 6.4E-3	50.73	3582	47.87	12480	4.34×10^{17}
SVT 1.1E-2	50.89	8022	47.81	19117	6.35×10^{17}

Appendix A-5 Operational parameter of XRPD.

Scan range	Sampling	Scan speed Measurement	Voltage (KV)	Current
	width	(degree/min) type		(mA)
	(degree)	1090		
10-80 degree	0.02	4.0 Ordinary	30.0	20.0
		(without		
		background)		

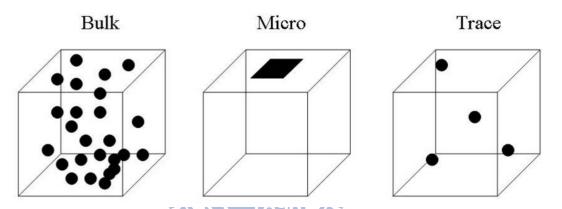
Appendix A-6 Operational parameter of UV-vis.

Measurement	Data	Starting	Ending	Sampling	Slit	Reference
	Mode	wavelength	wavelength	interval	width	
Wavelength	% R	900 nm	200 nm	1 nm	1 nm	Al ₂ O ₃

Appendix B Instrument principle

Appendix B-1 Time-of-Flight Secondary Ion Mass Spectrometer

SIMS is an analytical technique that can be used to characterize the surface and near surface (\sim 30 µm) region of solid. The technique uses a beam of energetic (0.5-20 keV) primary ions to sputter the sample surface, producing ionized secondary particles that are detected using a mass spectrometer. Besides, the detection limit for element is ppb \sim ppm, where is more sensitive than AES (0.1 %) or ESCA (0.01 %). And for chemical analysis, SIMS can detect bulk, miro and trace of sample which is shown in Appendix B-1.



Appendix B-1 Chemical analysis for three different types of sample. 90

SIMS measurements were performed with a TOF-SIMS IV (ION-TOF) spectrometer which use a Ga^+ or Au^+ to be analytic source and use an O_2^+ or Cs^+ to be sputter source. The thickness of sample is around 1 cm and area of sample is around 1 cm². The detection area is $100\times100~\mu\text{m}^2$. The sputter time is 120 seconds. The surface atomic ratio was calculated from the intensity of secondary ions which are normalized to relative sensitivity factor. A relative sensitivity factor (RSF) is a conversion factor from secondary ion intensity to atom density. The RSF is defined by sub-equation: 62

$$\rho_{\rm i} = \frac{I_i}{I_{\rm tot}} RSF \tag{B-1}$$

Where ρ_i is the impurity atom density in atoms/cm³, I_i is the impurity isotope secondary ion intensity in counts/s, I_m is the matrix isotope secondary ion intensity in counts/s, and RSF

has unit of atoms/cm³.

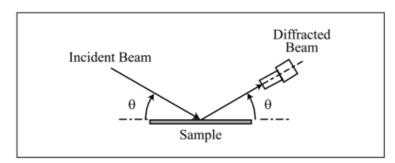
The surface atomic ratio can be calculated by sub-equation

$$\frac{n_1}{n_2} = \frac{I_1/RSF_1}{I_2/RSF_2}$$
 (B-2)

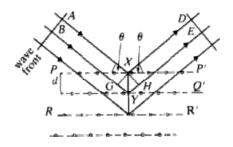
Where n denotes the atomic numbers, I is the intensity of secondary ions on SIMS spectra, RSF stands for the atomic relative sensitive factor of element.

Appendix B-2 X-ray powder diffractometry (XRPD)

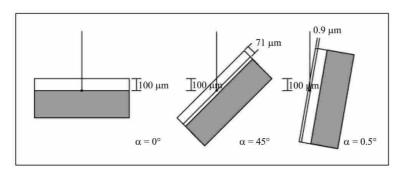
The bulk crystal structure of bulk materials were detected by Bragg's law. The device of XRPD is shown in Appendix B-2. And the principle of XRD is Bragg's law, which calculated the d-spacing of the crystal structure, as shown in Appendix B-3. But the thickness of X-ray detective limit is positive with $\sin \alpha / \mu$ (α is incidence angle and μ is adsorption constant of materials). Therefore, the thickness of XRPD detection is around $10{\sim}100~\mu m$ ($1/\mu$). But the thickness of thin film is quite lower than limit of XRPD, even several hundred Å. Moreover, while the thin film is detected by XRPD, the signal of sample would be cover by matrix. So, grazing incident diffraction, GID, method could vary the thickness of detection by change the incidence angle. Appendix B-4 shows the relationship between incidence angle and detective thickness. And Appendix B-5 shows the concept of GI-XRD.



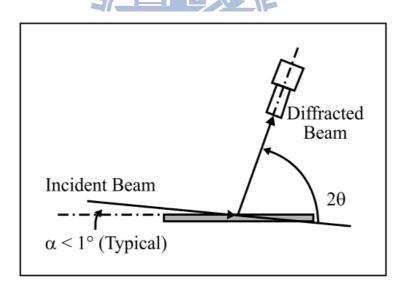
Appendix B-2 The concept of x-ray powder diffractometry device. 90



Appendix B-3 The concept of geometric figure for Bragg's law.⁹¹



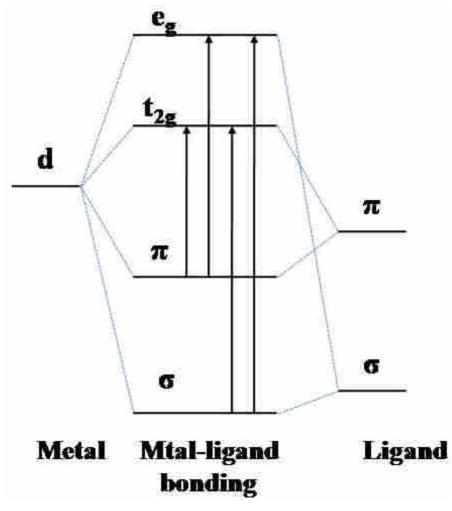
Appendix B-4 The relationship between incidence angle and detective thickness for GI-XRD.⁹⁰



Appendix B-5 The concept of grazing incident x-ray powder diffractometry device. 90

Appendix B-3 UV-vis diffuse reflectance spectroscopy (DRS)

UV-vis diffuse reflectance spectroscopy (DRS) was applied to study the bonding information for inorganic compounds. And the local structures of the vanadium ions in TiO_2 are often associated with the band positions of the ligand¹-to-metal charge transfer (LMCT) transition from an O^{2-} ion t_{1u} orbital to a M^{n+} metal e_g orbital.^{76, 92-94} In order to elucidate the optical properties for photocatalysts, UV-visible spectroscopy was used to examine the optical reflectance of the bulk and surface doping materials at different vanadium ions concentration. Thus, Appendix B-6 is shown the ligand-to-metal charge transfer (LMCT) transition for TiO_2 .



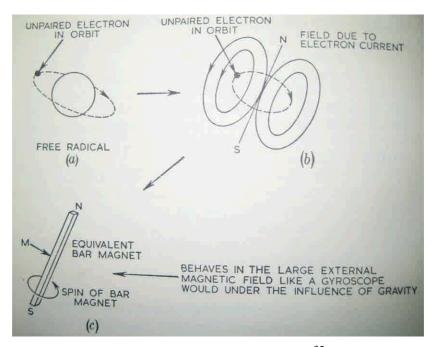
Appendix B-6 A simplified molecular orbital diagram illustrating the potential ligand to metal charge transfer transitions.^{5,67}.

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¹ In chemistry, a ligand is either an atom, ion, or molecule that bonds to a central metal to produce a coordination complex. The bonding between the metal and ligand generally involving formal donation of one or more of the ligand's electrons. The metal-ligand bonding ranges from covalent to more ionic. Furthermore, the metal-ligand bond order can range from one to three. http://en.wikipedia.org/wiki/Ligand

Appendix B-4 Electron paramagnetic resonance (EPR)

An unpaired electron which is rotating around the rest of the molecule is equivalent to a current flowing in a complete turn of wire without resistance, and thus it produces a magnetic filed which passes through its centre as shown in Appendix B-7. In the other word, the electron is circling around the molecule it acts rather like a gyroscope, with the dame reluctance to change the direction of its axis of spin. If a quantity of these free radicals is placed in strong unidirectional and constant value magnetic field, H, some of the bar magnets will take up a position relative to the d.c. field as shown in Appendix B-8.

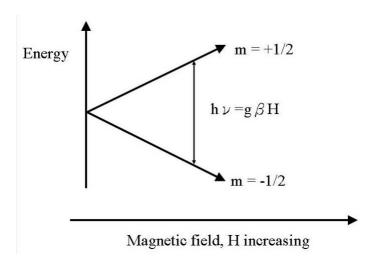


Appendix B-7 How a free radical acts a bar magnet with mass.³⁵

Such EPR spectra (Appendix B-8) are obtained by measuring the attenuation versus frequency (or wavelength) of a beam of electromagnetic radiation as it passes through a sample of matter. Transition can be induced between there levels by applying an oscillating magnetic field of frequency at right angles to the d.c. field. The relation between field and frequency for resonance of the free electron is

$$v = (g\beta/h)H \tag{B-3}$$

where g is g factor, β is Bohr magneton, H is magnetic field and h is Planck constant.



Appendix B-8 Energy-level scheme for the sample (e.g. free electron) as a function of applied magnetic field.⁸³

However, the transition elements are present for which shells inside the valence shell are not filled, so that unpaired electrons are always present. For example, the first transition group is the iron group in which the electrons start filling the 3d shell after the 4s valence electrons have filled. For free electron g factor has the value 2.0023. In most free radicals g lies very close to this value, where in the range 2.002 to 2.004.

EPR spectra of V-doped anatase are as expected for V^{4+} (S=1/2, I=7/2) being composed of essentially two or three groups of octets due to the coupling of a single electron with the vanadium nucleus. However, the Ti^{3+} and •OH would not appear after UV irradiation, because the Ti^{3+} ions would easily oxidization to Ti^{4+} and the electron would transfer to O_2 which is adsorption on the surface of TiO_2 (equation B-4). Moreover, oxygen was chemical adsorbed by O_2^{2-} ion in room to low temperature process. Besides, O_2^{2-} simultaneously have hole-reduction agent and electron consumed agent function, and O_2^{-} be the product by hole/electron consumed reaction. That is why O_2^{-} signal can be detected in EPR system after UV irradiation with low vanadium concentration.

The reaction between Ti³⁺ and oxygen:

$$Ti^{3+} + O_{2(gas)} \rightarrow Ti^{4+} + O_{2(adsorption)}^{-}$$
 (B-4)

The reaction between excited electron or hole and oxygen gas or ion:

$$TiO_2 + h\nu \rightarrow e^- + h^+ \tag{B-5}$$

$$h^+ + O_2^{2-} \to O_2^-$$
 (B-6)

$$O_2 + e^- \rightarrow \bullet O_2^- \tag{B-7}$$

The reaction between excited electron or hole and water:

$$h^{+} + H_{2}O \rightarrow \bullet OH + H^{+} \tag{B-8}$$

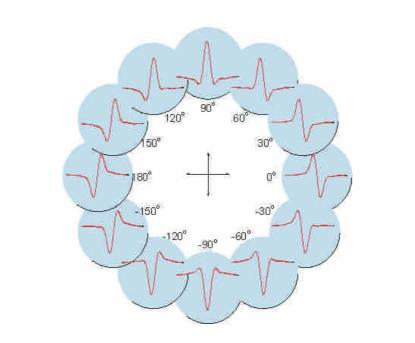
$$\bullet OH + O_2^{2-} \to O_2^{-} \tag{B-9}$$

The EPR spectra recorded at 77 K of all samples. Each sample contains 0.01 g powder which is filled in quartz tube in the dark or under UV light. Furthermore, the wavelength of UV light system (Moritex, MUV-250U-L) is 365 nm mainly and 150W. And the photograph of EPR instrument is presented in Appendix B-9. The temperature is control by He (3.8K to 300K) or N_2 (100 to 500k). The microwave frequency is 9.490 GHz, and its power is 8.012 mW. In addition, the range of magnetic field center is 3400 G where the sweep width and sweep time is 600 G and 167 second separately. And the resolution is 2048 point. Beside, the phase is 0.0 deg, which is shown in Appendix B-10. The electromagnet size is 10 inches and the length between is 72 mm.

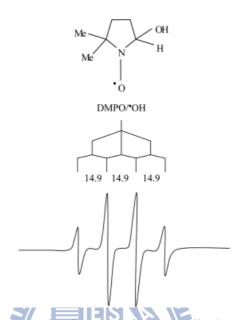
However, in order to understand the diffusion of interface generated-electron/hole, the concentration of hydroxyl radicals which were generated on the surface of materials were detected by ESR. The signal of radicals spin-trapped with 5,5-dimethyl-1-pyrroline N-oxide (DMPO, Aldrich) were detected by ESR, as shown in Appendix B-11. The 1 mL of 0.03 M DMPO solution was injected in 10 mL DI water that dissolve 10 mg samples. EPR samples were analyzed at 77 K with UV irradiation after 30 min O₂ aeration.



Appendix B-9 The photograph of EPR instrument.



Appendix B-10 The EPR phase control with different angle. 95



Appendix B- 11 The spectrum of spin trap of •OH radical with DMPO. And hyperfine splitting of DMPO/•OH ESR signal is 14.9 Gauss. This is characteristic of a DMPO adduct (1 : 2 : 2 : 1 quartet with hyperfine coupling of aN = aH = 14.9 Gauss) produced by spin trapping of a hydroxyl radical produced in a hydroxyl radical-generating system. 89

Appendix C BET Data

Appendix C-1 The specific surface area of bulk doping materials.

	Bulk doped materials				
Sample	VT	VT	VT	VT	VT
	4.41×10^{-5}	1.34×10^{-4}	5.09×10^{-4}	1.27×10^{-3}	1.22×10^{-2}
$S_{BET} (m^2/g)$	102	103	105	104	110

Appendix C-2 The specific surface area of all of surface doping materials.

	Surface doped materials				
Sample	TiO_2	SVT	SVT	SVT	SVT
		1.73×10^{-3}	3.47×10^{-3}	6.40×10^{-3}	1.10×10^{-2}
S_{BET} , (m^2/g)	99 ± 2	107	105	105	99

Appendix C-3 The specific surface area of all of surface doping material with pure vanadium ions.

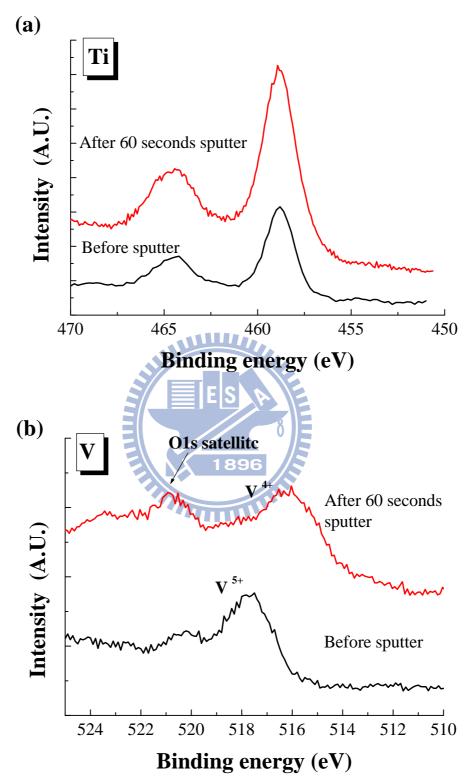
	Surface doping materials	
Sample	TiO ₂	SVTP 4.74×10^{-3}
S_{BET} , (m^2/g)	99 ± 2	103

Appendix D. ESCA analysis

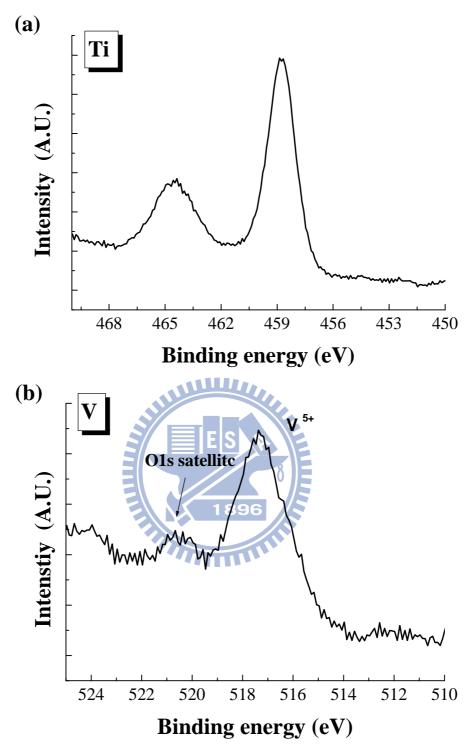
Appendix D-1 ESCA data for bulk and surface complex doping materials.

`	V 2p _{3/2} (eV)		Ti 2p _{3/2} Surface V/Ti (atomic ratio			atio)		
	$V^{{\rm I\hspace{1em}I}}$	$\mathbf{V}^{ ext{IV}}$	$\boldsymbol{V}^{\mathrm{V}}$	(eV)	$V^{{\rm I\hspace{1em}I}}/Ti$	V ^{IV} /Ti	V ^v /Ti	V/Ti
VT 2×10 ⁻¹	_a	-	517.4	458.8	-	-	0.61	0.61
(Sputter time :	515.2	516.2	518	458.9	0.09	0.31	0.10	0.50
60 seconds)								
SVT 3×10 ⁻¹	-	-	517.3	458.7	-		0.33	0.33



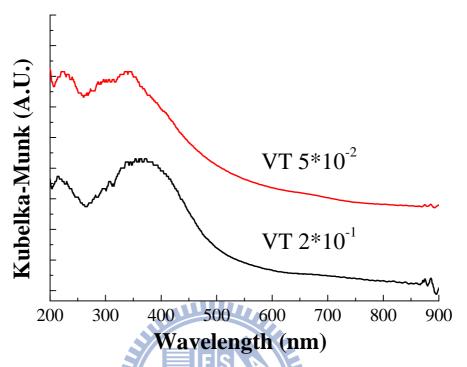


Appendix D-2 The XPS spectra of VT2×10⁻¹ illustrated before and after Ar ion gun sputter. (A) The evolution Ti (2p) XPS spectra and (B) The evolution V (3d) XPS spectra.



Appendix D-3 The evolution Ti (2p) and V (3d) XPS spectra of $SVT3 \times 10^{-1}$.

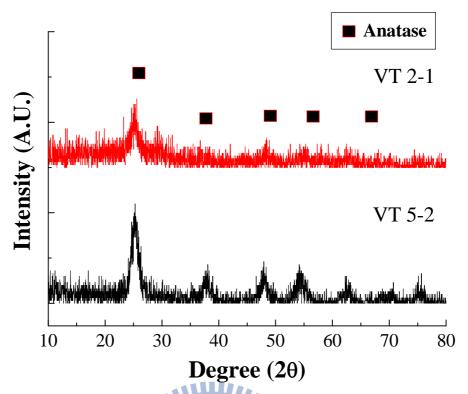
Appendix E Bulk doped materials with high vanadium ions



Appendix E-1 The UV-Vis spectra of VT5× 10^{-2} and VT 2× 10^{-1} .

Appendix E-2 The UV-Vis data of VT 5×10^{-2} and VT 2×10^{-1} .

Bulk doped materials						
Materials	Band gap (eV)					
TiO ₂	3.1					
VT 5×10 ⁻²	2.4					
VT 2×10 ⁻¹	2.4					



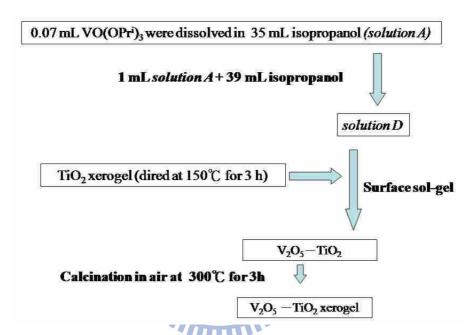
Appendix E-3 The XRD spectra of $VT5 \times 10^{-2}$ and $VT \times 10^{-1}$.

Appendix E-4 The XRD data of VT5×10⁻² and VT 2×10⁻¹.

Bulk doping materials					
Materials	Crystal size (nm)	d-spacing (nm)	Weight ratio of Rutile (%)		
TiO ₂	6.1 ± 0.6	350	31.1		
VT 5×10 ⁻²	5.5	352	_		
VT 2×10 ⁻¹	5.2	353	_		

Appendix F Vanadium-doped on the surface of TiO₂

Vanadium-doped materials are prepared by surface sol-gel process, as shown in Appendix F-1. The different from surface doped materials is lack of TTIP in *solution D*. To add $1.0 \, \mathrm{g}$ TiO₂ which is calcinated at $150 \, \mathrm{^{\circ}C}$ for 3h into sample tube and then inject 25 mL mixture precursor solution into tube. After 10 min immersion, the production was separated from solution by gravity. The solid was dried at $100 \, \mathrm{^{\circ}C}$ and then calcined at $300 \, \mathrm{^{\circ}C}$ for 3 h. The xerogel obtained was named SVTP.

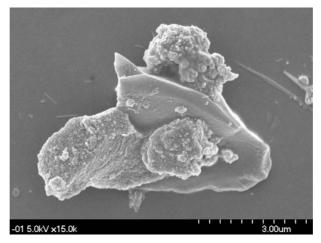


Appendix F-1 The synthetic process of surface doping materials.

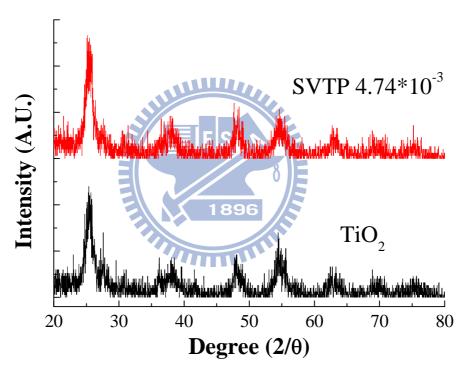
Appendix F-2 The bulk V-to-Ti atomic ratios of surface doped TiO₂ with pure vanadium.

Materials	Bulk V/Ti ratios ^a	Sample name
SVTP	4.74×10^{-3}	SVTP 4.74×10 ⁻³

^a determined by ICP-MS



Appendix F-3 SEM image of surface doped materials (pure).



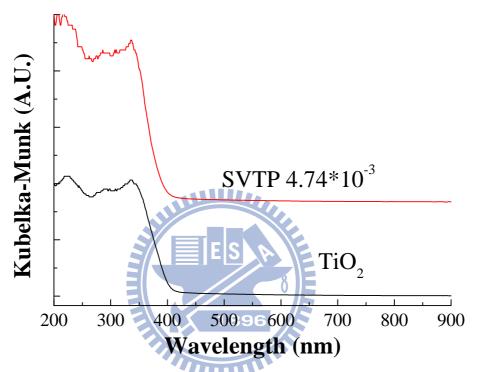
Appendix F-4 The XRD spectra of TiO_2 and SVTP 4.74×10^{-3} .

Appendix F-5 The XRD data of SVTP 4.74×10^{-3} and TiO₂.

Surface doping materials (Pure)					
Materials	Crystal size (nm)	d-spacing (pm)	Weight ratio of Rutile (%)		
TiO ₂	8.3 ± 0.1	350 ± 2	28.7		
SVTP 4.74×10 ⁻³	9.5	350	-		

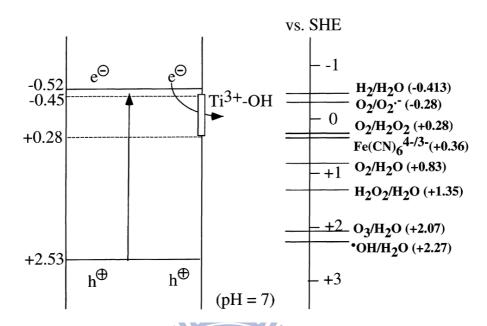
Appendix F-6 The specific surface area of all of surface doping material with pure vanadium ions.

	Surface doping mat	erials
Sample	TiO_2	SVTP 4.74×10 ⁻³
$S_{BET} (m^2/g)$	99 ± 2	103



Appendix F-7 The UV-DRS spectra of TiO₂ and SVTP 4.74×10^{-3} .

Appendix G Redox potential



Appendix G-1 Schematic diagram showing the potentials for various redox processes occurring on the TiO_2 surface at pH 7.

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Appendix H Langmuir-Hinshelwood kinetics

Langmuir-Hinshelwood (LH) kinetics which is the most commonly used kinetic expression to explain the kinetics of the heterogeneous catalytic processes. The Langmuir-Hinshelwood equation is given by:

$$r = -\frac{dC}{dt} = \frac{k_r KC}{1 + KC} \tag{H-1}$$

where r respects the rate of reaction that changes with time, C is concentration at any time t during degradation, K respects equilibrium constant for adsorption of the substrate onto catalyst, and k_r respects limiting rate of reaction at maximum coverage under the given experimental condition.

The constants k_r , and K can be calculated from the corresponding integrated expression. This equation can be integrated between the limits: $C=C_0$ at t=0 and C=C at t=t. The integrated expression is given by:

$$\ln(\frac{C}{C_0}) + K(C_o - C) = k_r Kt$$
(H-2)

Most of researchers approximated equation H-1 to first order kinetics for the condition C < 1 mM, as KC is much less than unity. ^{97, 98} If the term KC << 1 then equation H-1 is reduce to :

$$r = k_r KC$$
 (H-3)

In the case of equation H-3, the constants k_r , and K can be calculated from the corresponding integrated expression. This equation can be integrated between the limits: $C=C_0$ at t=0 and C=C at t=t. The integrated expression is given by:

$$-\ln(\frac{C}{C_0}) = k_1 t \tag{H-4}$$

where $k_1 = k_r K$, which respects first order rate constants.

In addition, for C>5 mM, the LH kinetics reduced to zero order when KC>>1, in which case the reaction rate will be maximal. Thus the Langmuir-type kinetic rate expression reduces to a zero-order rate expression and the overall rate would not depend on external mass transfer, i.e., be kinetically limited. The concentration versus time will follow a linear relationship. Then the zero-order rate expression should be expressed as: 97,98

$$r = -\frac{dC}{dt} = k_0 \tag{H-5}$$

where k_0 respects zero-order rate constant.



Appendix I TEM of surface doped materials

